# Old Company Name in Catalogs and Other Documents

On April 1<sup>st</sup>, 2010, NEC Electronics Corporation merged with Renesas Technology Corporation, and Renesas Electronics Corporation took over all the business of both companies. Therefore, although the old company name remains in this document, it is a valid Renesas Electronics document. We appreciate your understanding.

Renesas Electronics website: <a href="http://www.renesas.com">http://www.renesas.com</a>

April 1<sup>st</sup>, 2010 Renesas Electronics Corporation

Issued by: Renesas Electronics Corporation (http://www.renesas.com)

101.P

Send any inquiries to http://www.renesas.com/inquiry.



#### Notice

- 1. All information included in this document is current as of the date this document is issued. Such information, however, is subject to change without any prior notice. Before purchasing or using any Renesas Electronics products listed herein, please confirm the latest product information with a Renesas Electronics sales office. Also, please pay regular and careful attention to additional and different information to be disclosed by Renesas Electronics such as that disclosed through our website.
- Renesas Electronics does not assume any liability for infringement of patents, copyrights, or other intellectual property rights
  of third parties by or arising from the use of Renesas Electronics products or technical information described in this document.
  No license, express, implied or otherwise, is granted hereby under any patents, copyrights or other intellectual property rights
  of Renesas Electronics or others.
- 3. You should not alter, modify, copy, or otherwise misappropriate any Renesas Electronics product, whether in whole or in part.
- 4. Descriptions of circuits, software and other related information in this document are provided only to illustrate the operation of semiconductor products and application examples. You are fully responsible for the incorporation of these circuits, software, and information in the design of your equipment. Renesas Electronics assumes no responsibility for any losses incurred by you or third parties arising from the use of these circuits, software, or information.
- 5. When exporting the products or technology described in this document, you should comply with the applicable export control laws and regulations and follow the procedures required by such laws and regulations. You should not use Renesas Electronics products or the technology described in this document for any purpose relating to military applications or use by the military, including but not limited to the development of weapons of mass destruction. Renesas Electronics products and technology may not be used for or incorporated into any products or systems whose manufacture, use, or sale is prohibited under any applicable domestic or foreign laws or regulations.
- 6. Renesas Electronics has used reasonable care in preparing the information included in this document, but Renesas Electronics does not warrant that such information is error free. Renesas Electronics assumes no liability whatsoever for any damages incurred by you resulting from errors in or omissions from the information included herein.
- 7. Renesas Electronics products are classified according to the following three quality grades: "Standard", "High Quality", and "Specific". The recommended applications for each Renesas Electronics product depends on the product's quality grade, as indicated below. You must check the quality grade of each Renesas Electronics product before using it in a particular application. You may not use any Renesas Electronics product for any application categorized as "Specific" without the prior written consent of Renesas Electronics. Further, you may not use any Renesas Electronics product for any application for which it is not intended without the prior written consent of Renesas Electronics. Renesas Electronics shall not be in any way liable for any damages or losses incurred by you or third parties arising from the use of any Renesas Electronics product for an application categorized as "Specific" or for which the product is not intended where you have failed to obtain the prior written consent of Renesas Electronics. The quality grade of each Renesas Electronics product is "Standard" unless otherwise expressly specified in a Renesas Electronics data sheets or data books, etc.
  - "Standard": Computers; office equipment; communications equipment; test and measurement equipment; audio and visual equipment; home electronic appliances; machine tools; personal electronic equipment; and industrial robots.
  - "High Quality": Transportation equipment (automobiles, trains, ships, etc.); traffic control systems; anti-disaster systems; anti-crime systems; safety equipment; and medical equipment not specifically designed for life support.
  - "Specific": Aircraft; aerospace equipment; submersible repeaters; nuclear reactor control systems; medical equipment or systems for life support (e.g. artificial life support devices or systems), surgical implantations, or healthcare intervention (e.g. excision, etc.), and any other applications or purposes that pose a direct threat to human life.
- 8. You should use the Renesas Electronics products described in this document within the range specified by Renesas Electronics, especially with respect to the maximum rating, operating supply voltage range, movement power voltage range, heat radiation characteristics, installation and other product characteristics. Renesas Electronics shall have no liability for malfunctions or damages arising out of the use of Renesas Electronics products beyond such specified ranges.
- 9. Although Renesas Electronics endeavors to improve the quality and reliability of its products, semiconductor products have specific characteristics such as the occurrence of failure at a certain rate and malfunctions under certain use conditions. Further, Renesas Electronics products are not subject to radiation resistance design. Please be sure to implement safety measures to guard them against the possibility of physical injury, and injury or damage caused by fire in the event of the failure of a Renesas Electronics product, such as safety design for hardware and software including but not limited to redundancy, fire control and malfunction prevention, appropriate treatment for aging degradation or any other appropriate measures. Because the evaluation of microcomputer software alone is very difficult, please evaluate the safety of the final products or system manufactured by you.
- 10. Please contact a Renesas Electronics sales office for details as to environmental matters such as the environmental compatibility of each Renesas Electronics product. Please use Renesas Electronics products in compliance with all applicable laws and regulations that regulate the inclusion or use of controlled substances, including without limitation, the EU RoHS Directive. Renesas Electronics assumes no liability for damages or losses occurring as a result of your noncompliance with applicable laws and regulations.
- 11. This document may not be reproduced or duplicated, in any form, in whole or in part, without prior written consent of Renesas Electronics
- 12. Please contact a Renesas Electronics sales office if you have any questions regarding the information contained in this document or Renesas Electronics products, or if you have any other inquiries.
- (Note 1) "Renesas Electronics" as used in this document means Renesas Electronics Corporation and also includes its majority-owned subsidiaries.
- (Note 2) "Renesas Electronics product(s)" means any product developed or manufactured by or for Renesas Electronics.

# Regarding the change of names mentioned in the document, such as Hitachi Electric and Hitachi XX, to Renesas Technology Corp.

The semiconductor operations of Mitsubishi Electric and Hitachi were transferred to Renesas Technology Corporation on April 1st 2003. These operations include microcomputer, logic, analog and discrete devices, and memory chips other than DRAMs (flash memory, SRAMs etc.) Accordingly, although Hitachi, Hitachi, Ltd., Hitachi Semiconductors, and other Hitachi brand names are mentioned in the document, these names have in fact all been changed to Renesas Technology Corp. Thank you for your understanding. Except for our corporate trademark, logo and corporate statement, no changes whatsoever have been made to the contents of the document, and these changes do not constitute any alteration to the contents of the document itself.

Renesas Technology Home Page: http://www.renesas.com

NO OCA

Renesas Technology Corp. Customer Support Dept. April 1, 2003



#### **Cautions**

Keep safety first in your circuit designs!

1. Renesas Technology Corporation puts the maximum effort into making semiconductor products better and more reliable, but there is always the possibility that trouble may occur with them. Trouble with semiconductors may lead to personal injury, fire or property damage.

Remember to give due consideration to safety when making your circuit designs, with appropriate measures such as (i) placement of substitutive, auxiliary circuits, (ii) use of nonflammable material or (iii) prevention against any malfunction or mishap.

#### Notes regarding these materials

- 1. These materials are intended as a reference to assist our customers in the selection of the Renesas Technology Corporation product best suited to the customer's application; they do not convey any license under any intellectual property rights, or any other rights, belonging to Renesas Technology Corporation or a third party.
- 2. Renesas Technology Corporation assumes no responsibility for any damage, or infringement of any third-party's rights, originating in the use of any product data, diagrams, charts, programs, algorithms, or circuit application examples contained in these materials.
- 3. All information contained in these materials, including product data, diagrams, charts, programs and algorithms represents information on products at the time of publication of these materials, and are subject to change by Renesas Technology Corporation without notice due to product improvements or other reasons. It is therefore recommended that customers contact Renesas Technology Corporation or an authorized Renesas Technology Corporation product distributor for the latest product information before purchasing a product listed herein.
  - The information described here may contain technical inaccuracies or typographical errors. Renesas Technology Corporation assumes no responsibility for any damage, liability, or other loss rising from these inaccuracies or errors.
  - Please also pay attention to information published by Renesas Technology Corporation by various means, including the Renesas Technology Corporation Semiconductor home page (http://www.renesas.com).
- 4. When using any or all of the information contained in these materials, including product data, diagrams, charts, programs, and algorithms, please be sure to evaluate all information as a total system before making a final decision on the applicability of the information and products. Renesas Technology Corporation assumes no responsibility for any damage, liability or other loss resulting from the information contained herein.
- 5. Renesas Technology Corporation semiconductors are not designed or manufactured for use in a device or system that is used under circumstances in which human life is potentially at stake. Please contact Renesas Technology Corporation or an authorized Renesas Technology Corporation product distributor when considering the use of a product contained herein for any specific purposes, such as apparatus or systems for transportation, vehicular, medical, aerospace, nuclear, or undersea repeater use.
- 6. The prior written approval of Renesas Technology Corporation is necessary to reprint or reproduce in whole or in part these materials.
- 7. If these products or technologies are subject to the Japanese export control restrictions, they must be exported under a license from the Japanese government and cannot be imported into a country other than the approved destination.
  - Any diversion or reexport contrary to the export control laws and regulations of Japan and/or the country of destination is prohibited.
- 8. Please contact Renesas Technology Corporation for further details on these materials or the products contained therein.



Rev. 6.0 Sept. 1998

## **Description**

The HD404019R series are HMCS400-series CMOS 4-bit single-chip microcomputers. Each device incorporates a ROM, RAM, I/O, serial interface, and two timer/counters, and contains high-voltage I/O pins including high-current output pins to directly drive fluorescent displays.

The HD404019R series includes four chips. The HD404019R and HD40L4019R are Mask ROM versions. The HD4074019 and HD407L4019 are PROM versions. The HD40L4019R and HD407L4019 are low-voltage operation versions.

#### **Features**

- 16,384-word × 10-bit ROM
  - Mask ROM: HD404019R, HD40L4019R
  - -- PROM: HD4074019, HD407L4019
- 992-digit × 4-bit RAM
- 58 I/O pins, including 26 high-voltage I/O pins (40 V max.)
- Two timer/counters
  - 8-bit free-running timer
  - 8-bit auto-reload timer/counter
- Clock synchronous 8-bit serial interface
- Five interrupt sources
  - Two by external sources
  - Two by timer/counters
  - One by serial interface
- Subroutine stack, up to 16 levels including interrupts
- Minimum instruction execution time: 0.89 μs
- · Low-power dissipation modes
  - Standby: Stops instruction execution while allowing clock oscillation and interrupt functions to operate
  - Stop: Stops instruction execution and clock oscillation while retaining RAM data

- On-chip oscillator
  - Crystal or ceramic oscillator
  - External clock
- Packages
  - 64-pin shrink type plastic DIP
  - 64-pin flat plastic package
  - 64-pin shrink type ceramic DIP with window

# **Ordering Information**

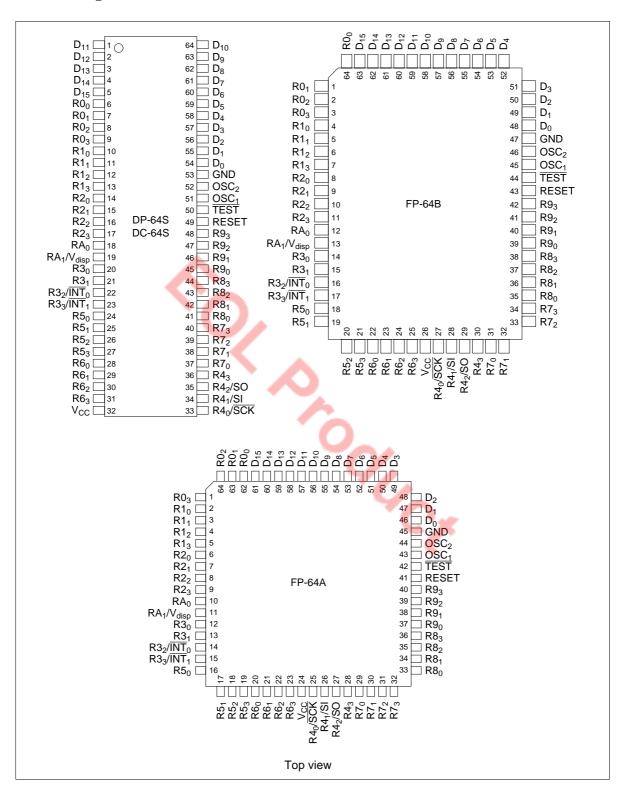
Туре	Product Name	Model Name	Package	
Mask ROM	HD404019R	HD404019RS	DP-64S	
		HD404019RH	FP-64A	
		HD404019RFS	FP-64B	
	HD40L4019R	HD40L4019RS	DP-64S	
		HD40L4019RH	FP-64A	
ZTAT™	HD4074019	HD4074019S	DP-64S	
		HD4074019H	FP-64A	
		HD4074019FS	FP-64B	
		HD4074019C	DC-64S	
	HD407L4019	HD407L4019S	DP-64S	
		HD407L4019H	FP-64A	

ZTAT™: Zero Turn Around Time. ZTAT is a trademark of Hitachi Ltd.

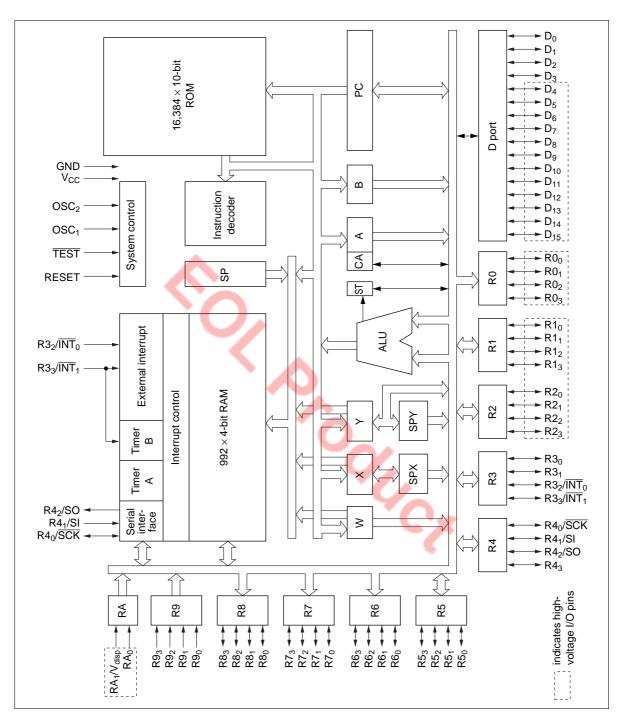
# Differences between ZTAT $^{\text{TM}}$ and Mask ROM Version

		<b>ZTAT</b> <sup>TM</sup>		Mask ROM Versi	ion
Item		HD4074019	HD407L4019	HD404019R	HD40L4019R
Power supply voltage (V)		4.5 to 5.5 V	3.0 to 5.5 V	3.5 to 6.0 V	2.7 to 6.0 V
Instruction cycle time (t <sub>cyc</sub> )		0.89 to 20 μs	1.12 to 20 μs	0.89 to 10 μs	1.12 to 10 μs
ROM (word)		$16,\!384\times 10\text{-bit}$	$16,\!384\times 10\text{-bit}$	$16,384\times10\text{-bit}$	$16,\!384\times 10\text{-bit}$
RAM		992 × 4-bit	992 × 4-bit	992 × 4-bit	992 × 4-bit
I/O pin circuit*1	Standard pins	NMOS open drain	NMOS open drain	Each pin can be with MOS (NMOS open pull-up MOS, or Co	en drain), with
	High voltage pins	PMOS open drain	PMOS open drain	Each pin can be well-down MOS	
Oscillator stabilization*2	Crystal	Available	Available	Available	Available
	Ceramic	Ava <mark>ila</mark> ble	Available	Available	Available
Package	DP-64S	Available	Available	Available	Available
	FP-64A	Available	Available	Available	Available
	FP-64B	Available	)—	Available	_
	DC-64S	Available	<b>A</b>	_	_
—: Not available Notes: 1. See table 17. 2. See table 20.					

#### Pin Arrangement



# **Block Diagram**



#### **Pin Functions**

#### **Power Supply**

**V**<sub>CC</sub>: Apply the power supply voltage to this pin.

**GND:** Connect to ground.

 $V_{disp}$ : Power supply pin (multiplexed with RA<sub>1</sub>) for high-voltage I/O pins with a maximum voltage of 40 V ( $V_{CC} - 40 \text{ V}$ ). For details, see the Input/Output section.

**TEST:** For test purposes only. Connect it to  $V_{CC}$ .

**RESET:** Resets the MCU. For details, see the Reset section.

#### **Oscillators**

**OSC<sub>1</sub>**, **OSC<sub>2</sub>**: OSC<sub>1</sub> and **OSC<sub>2</sub>** can be connected to a crystal resonator, ceramic resonator or an external oscillator circuit. For details, see the Internal Oscillator Circuit section.

#### **Ports**

 $\mathbf{D_0}$  to  $\mathbf{D_{15}}$  (D Port): An input/output port addressed by bits. These 16 pins are all input/output pins.  $D_0$  to  $D_3$  are standard pins and  $D_4$  to  $D_{15}$  are high-voltage pins. The circuit type for each pin can be selected using a mask option. For details, see the Input/Output section.

**R0 to RA**<sub>1</sub> (**R Ports**): R0 to R9 are 4-bit I/O ports. Only RA is a 2-bit port. R9 and RA are input ports, and R0 to R8 are I/O ports. R0, R1, R2, and RA are high-voltage ports, and R3 to R9 are standard ports. Each pin has a mask option which selects its circuit type. The pins R3<sub>2</sub>, R3<sub>3</sub>, R4<sub>0</sub>, R4<sub>1</sub>, and R4<sub>2</sub> are multiplexed with  $\overline{\text{INT}}_0$ ,  $\overline{\text{INT}}_1$ ,  $\overline{\text{SCK}}$ , SI, and SO, respectively. For details, see the Input/Output section.

#### **Interrupts**

 $\overline{\textbf{INT}_0}$ ,  $\overline{\textbf{INT}_1}$ : External interrupts for the MCU.  $\overline{\textbf{INT}_1}$  can be used as an external event input pin for timer B.  $\overline{\textbf{INT}_0}$  and  $\overline{\textbf{INT}_1}$  are multiplexed with R3<sub>2</sub> and R3<sub>3</sub>, respectively. For details, see the Interrupt section.

#### **Serial Interface**

 $\overline{SCK}$ , SI, SO: The transmit clock I/O pin ( $\overline{SCK}$ ), serial data input pin (SI), and serial data output pin (SO) are used for serial interface.  $\overline{SCK}$ , SI, and SO are multiplexed with R4<sub>0</sub>, R4<sub>1</sub>, and R4<sub>2</sub>, respectively. For details, see the Serial Interface section.

#### **Memory Map**

#### **ROM Memory Map**

The MCU contains a 16,384-word  $\times$  10-bit ROM (mask ROM or PROM). It is described in the following paragraphs and by the ROM memory map in figure 1.

**Vector Address Area (\$0000 to \$000F):** Locations \$0000 through \$000F are reserved for JMPL instructions to branch to the starting address of the initialization program and of the interrupt programs. After reset or an interrupt routine is processed, the program is executed from the vector address.

**Zero-Page Subroutine Area (\$0000 to \$003F):** Locations \$0000 through \$003F are reserved for subroutines. The CAL instruction branches to subroutines.

**Pattern Area (\$0000 to \$0FFF):** Locations \$0000 through \$0FFF are reserved for ROM data. The P instruction can refer to the ROM data as a pattern.

Program Area (\$0000 to \$3FFF): Locations from \$0000 to \$3FFF can be used for program code.

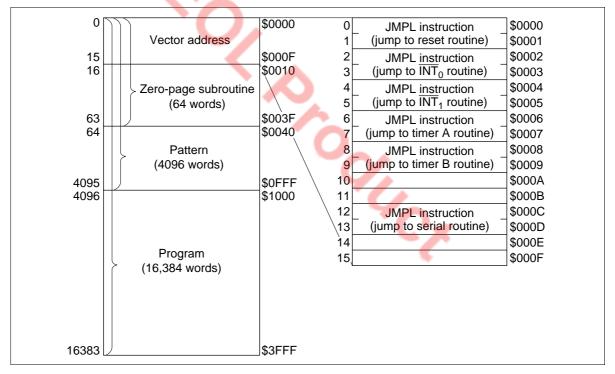


Figure 1 ROM Memory Map

#### **RAM Memory Map**

The MCU also contains a 992-digit × 4-bit RAM as the data and stack area. In addition to these areas, interrupt control bits and special function registers are also mapped on the RAM memory space. The RAM memory map (figure 2) is described in the following paragraphs.

**Interrupt Control Bits Area (\$000 to \$003):** The interrupt control bits area (figure 3) is used for interrupt control. It is accessible only by RAM bit manipulation instructions. However, the interrupt request flag cannot be set by software. The RSP bit is used only to reset the stack pointer.

**Special Function Registers Area** (\$004 to \$00B): The special function registers are the mode or data registers for the external interrupt, the serial interface, and the timer/counters. These registers are classified into three types: write-only, read-only, and read/write as shown in figure 2. These registers cannot be accessed by RAM bit manipulation instructions.

**Data Area (\$020 to \$3BF):** The 16 digits, \$020 through \$02F, of the data area are called memory registers (MR) and are accessible by the LAMR and XMRA instructions (figure 4).

**Stack Area** (\$3C0 to \$3FF): Locations \$3C0 through \$3FF are reserved for LIFO stacks to save the contents of the program counter (PC), status flag (ST), and carry flag (CA) when subroutine calls (CAL instruction, CALL instruction) or interrupts are processed. This area can be used as a 16-level nesting stack in which one level requires 4 digits. Figure 4 shows the save condition. The program counter is restored by the RTN and RTNI instructions. The status and carry flags are restored only by the RTNI instruction. This area, when not used as a stack, is available as a data area.



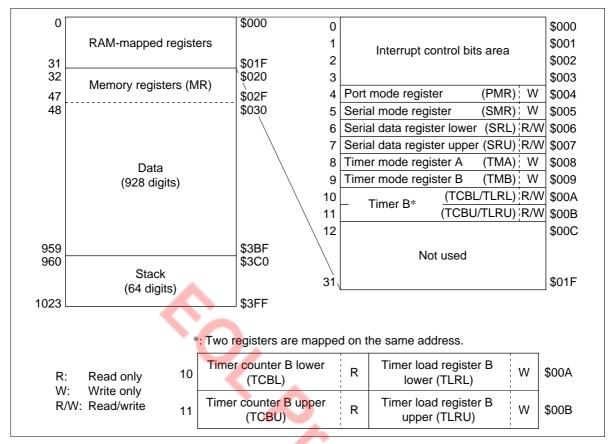


Figure 2 RAM Memory Map

OLCX.

	Bit 3	Bit 2	Bit 1	Bit 0	
0	IM0 (IM of INT <sub>0</sub> )	IF0 (IF of INT <sub>0</sub> )	RSP (Reset SP bit)	IE (Interrupt enable flag)	\$000
1	IMTA (IM of timer A)	IFTA (IF of timer A)	IM1 (IM of INT <sub>1</sub> )	IF1 (IF of INT <sub>1</sub> )	\$001
2	Not used	Not used	IMTB (IM of timer B)	IFTB (IF of timer B)	\$002
3	Not used	Not used	IMS (IM of serial)	IFS (IF of serial)	\$003

IF: Interrupt request flagIM: Interrupt maskIE: Interrupt enable flagSP: Stack pointer

Note: Each bit of the interrupt control bit area is set by the SEM/SEMD instruction, reset by the REM/REMD instruction, and tested by the TM/TMD instruction. It is not affected by other instructions. Furthermore the interrupt request flag is not affected by the SEM/SEMD instruction. The value of the status flag becomes invalid when the unusable bits are tested.

Figure 3 Interrupt Control Bits Area Configuration

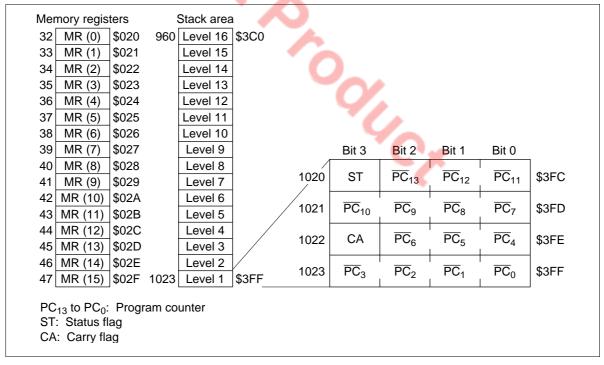


Figure 4 Configuration of Memory Registers, Stack Area, and Stack Position

#### **Functional Description**

#### **Registers and Flags**

The MCU has nine registers and two flags for the CPU operations (figure 5).

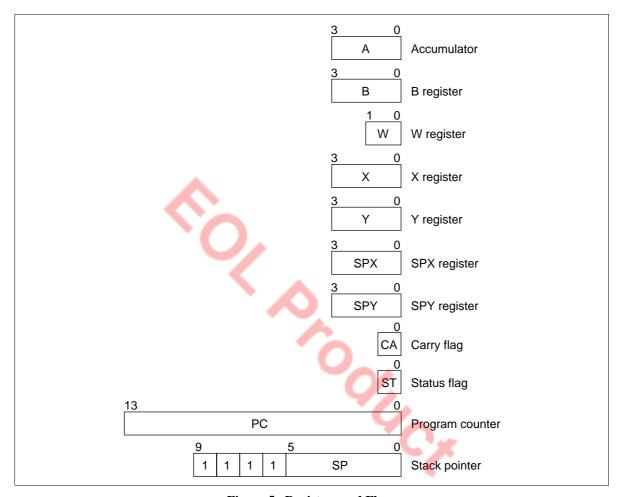


Figure 5 Registers and Flags

**Accumulator** (A), B Register (B): The 4-bit accumulator and B register hold the results from the arithmetic logic unit (ALU), and transfer data to/from memory, I/O, and other registers.

W Register (W), X Register (X), Y Register (Y): The 2-bit W register, and the 4-bit X and Y registers indirectly address RAM. The Y register is also used for D-port addressing.

**SPX Register (SPX), SPY Register (SPY):** The 4-bit registers SPX and SPY assist the X and Y registers, respectively.

**Carry Flag (CA):** The carry flag (CA) stores the overflow from the ALU generated by an arithmetic operation. It is also affected by the SEC, REC, ROTL, and ROTR instructions.

During an interrupt, a carry is pushed onto the stack. It is restored by the RTNI instruction, but not by the RTN instruction.

**Status Flag (ST):** The status flag (ST) holds the ALU overflow, ALU non-zero, and the results of a bit test instruction for the arithmetic or compare instructions. It is a branch condition of the BR, BRL, CAL, or CALL instruction. The value for the status flag remains unchanged until the next arithmetic, compare, or bit test instruction is executed. The status becomes a 1 after the BR, BRL, CAL, or CALL instruction is either executed or skipped. During an interrupt, the status is pushed onto the stack. It is restored back from the stack by the RTNI instruction, but not by the RTN instruction.

**Program Counter (PC):** The program counter is a 14-bit binary counter which controls the sequence in which the instructions stored in ROM are executed.

Stack Pointer (SP): The stack pointer (SP) points to the address of the next stack area (up to 16 levels).

The stack pointer is initialized to RAM address \$3FF. It is decremented by 4 when data is pushed onto the stack, and incremented by 4 when data is restored from it. The stack can only be used up to 16 levels deep because the high-order four bits of the stack pointer are fixed at 1111.

The stack pointer is initialized to \$3FF by either MCU reset or by the RSP bit reset from the REM/REMD instruction.

#### **Interrupts**

Five interrupt sources are available on the MCU: external requests ( $\overline{INT}_0$ ,  $\overline{INT}_1$ ), timer/counters (timers A and B), and serial port (serial). For each source, an interrupt request flag (IF) interrupt mask (IM), and interrupt vector addresses control and maintain the interrupt request. The interrupt enable flag (IE) also controls interrupt operations.

Interrupt Control Bits and Interrupt Processing: The interrupt control bits are mapped on \$000 through \$003 of the RAM space. They are accessible by RAM bit manipulation instructions. (The interrupt request flag (IF) cannot be set by software.) The interrupt enable flag (IE) and IF are cleared to 0, and the interrupt mask (IM) is set to 1 by MCU reset.

Figure 6 is a block diagram of the interrupt control circuit. Table 1 shows the interrupt priority and vector addresses, and table 2 shows the interrupt conditions corresponding to each interrupt source.

An interrupt request is generated when IF is set to 1 and IM is 0. If IE is 1 at this time, the interrupt will be activated and vector addresses will be generated from the priority PLA corresponding to the interrupt source.

Table 1 **Vector Addresses and Interrupt Priority** 

Reset/Interrupt	Priority	Vector Addresses
RESET	_	\$0000
ĪNT <sub>0</sub>	1	\$0002
ĪNT <sub>1</sub>	2	\$0004
Timer A	3	\$0006
Timer B	4	\$0008
Serial	5	\$000C

Table 2 **Interrupt Conditions** 

Table 2 Interrupt Condit			460	*	
	Interrupt	Source			
Interrupt Control Bit	INT₀	ĪNT₁	Timer A	Timer B	Serial
IE	1	1	1	1	1
IF0 · ĪMO	1	0	0	0	0
IF1 · ĪM1	*	1	0	0	0
IFTA · ĪMTA	*	*	1	0	0
IFTB · ĪMTB	*	*	*	1	0
IFS · ĪMS	*	*	*	*	1

Note: \* Indicates don't care

Figure 7 shows the interrupt processing sequence, and figure 8 shows the interrupt processing flowchart. If an interrupt is requested, the instruction being executed finishes in the first cycle. The IE is reset in the second cycle. In the second and third cycles, the carry flag, status flag, and program counter are pushed onto the stack. In the third cycle, the instruction is re-executed after jumping to the vector address.

At each vector address, program the JMPL instruction to branch to the starting address of the interrupt program. The IF which caused the interrupt must be reset by software in the interrupt program.

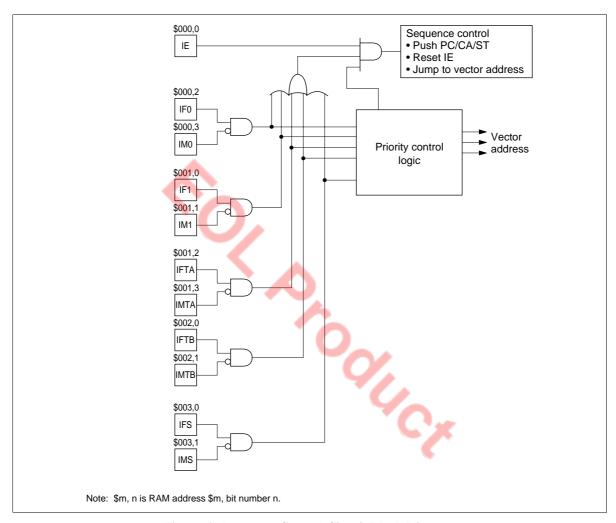


Figure 6 Interrupt Control Circuit Block Diagram

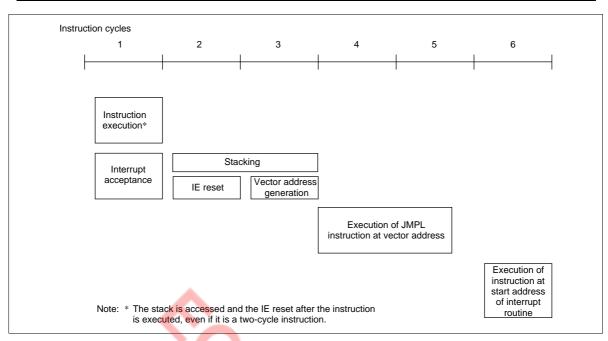


Figure 7 Interrupt Processing Sequence

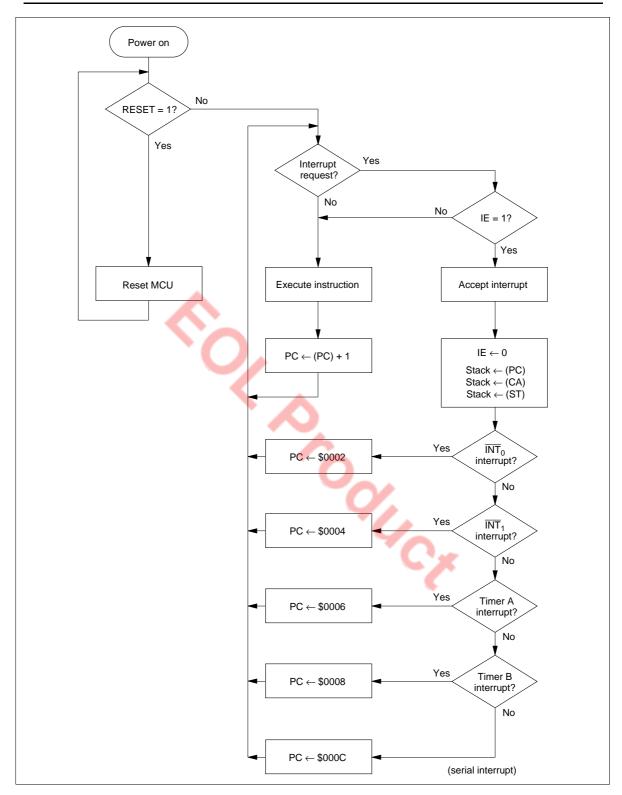


Figure 8 Interrupt Processing Flowchart

**Interrupt Enable Flag (IE: \$000, Bit 0):** The interrupt enable flag enables/disables interrupt requests as shown in table 3. It is reset by an interrupt and set by the RTNI instruction.

Table 3 Interrupt Enable Flag

IE	Interrupt Enable/Disable
0	Disabled
1	Enabled

**External Interrupts** ( $\overline{INT_0}$ ,  $\overline{INT_1}$ ): The external interrupt request inputs ( $\overline{INT_0}$ ,  $\overline{INT_1}$ ) can be selected by the port mode register (PMR: \$004). Setting bit 3 and bit 2 of PMR causes the R3<sub>3</sub>/ $\overline{INT_1}$  and R3<sub>2</sub>/ $\overline{INT_0}$  pins to be used as  $\overline{INT_1}$  and  $\overline{INT_0}$ , respectively.

The external interrupt request flags (IF0, IF1) are set at the falling edge of the  $\overline{INT}_0$  and  $\overline{INT}_1$  inputs. (Refer to table 4.)

The  $\overline{INT_1}$  input can be used as a clock signal input to timer B in which timer B counts up at each falling edge of the  $\overline{INT_1}$  input. When  $\overline{INT_1}$  is used as the timer B external event input, the external interrupt mask (IM1) has to be set so that the interrupt request by  $\overline{INT_1}$  will not be accepted. (Refer to table 5.)

Table 4 External Interrupt Request Flags

IF0, IF1	Interrupt Request	
0	No	
1	Yes	

Table 5 External Interrupt Masks

IMO, IM1	Interrupt Request	* C)
0	Enabled	70
1	Disabled (masked)	
		<u> </u>

External Interrupt Request Flags (IF0: \$000, Bit 2; IF1: \$001, Bit 0): The external interrupt request flags (IF0, IF1) are set at the falling edge of the  $\overline{INT}_0$  and  $\overline{INT}_1$  inputs, respectively.

External Interrupt Masks (IM0: \$000, Bit 3; IM1: \$001, Bit 1): The external interrupt masks mask the external interrupt requests.

**Port Mode Register (PMR: \$004):** The port mode register is a 4-bit write-only register which controls the  $R3_2/\overline{INT}_0$  pin,  $R3_3/\overline{INT}_1$  pin,  $R4_1/SI$  pin, and  $R4_2/SO$  pin as shown in table 6. The port mode register will be initialized to \$0 by MCU reset. These pins are therefore initially used as ports.

<b>HD404</b>	019R Series
Table 6	Port Mode Register
PMR3	R3 <sub>3</sub> /INT <sub>1</sub> Pin
0	Used as R3 <sub>3</sub> port input/output pin
1	Used as INT₁ input pin
PMR2	$R3_2/\overline{INT}_0$ Pin
0	Used as R3 <sub>2</sub> port input/output pin
1	Used as $\overline{INT}_{\scriptscriptstyle{0}}$ input pin
PMR1	R4₁/SI Pin
0	Used as R4 <sub>1</sub> port input/output pin
1	Used as SI input pin
PMR0	R4 <sub>2</sub> /SO Pin
0	Used as R4 <sub>2</sub> port input/output pin
1	Used as SO output pin

#### **Serial Interface**

The serial interface is used to transmit/receive 8-bit data serially. It consists of the serial data register, the serial mode register, the octal counter, and the multiplexer as illustrated in figure 9. Pin  $R4_0/\overline{SCK}$  and the transmit clock signal are controlled by the serial mode register. The contents of the serial data register can be written into or read out by software. The data in the serial data register can be shifted synchronously with the transmit clock signal.

The STS instruction initiates serial interface operations and resets the octal counter to \$0. The counter starts to count at the falling edge of the transmit clock ( $\overline{SCK}$ ) signal and increments by one at the rising edge of  $\overline{SCK}$ . When the octal counter is reset to \$0 after eight transmit clock signals, or a transmit/receive operation is discontinued, the serial interrupt request flag will be set.

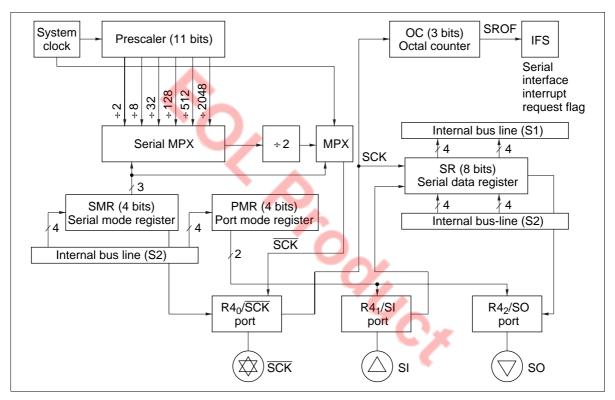


Figure 9 Serial Interface Block Diagram

**Serial Mode Register (SMR: \$005):** The 4-bit write-only serial mode register controls the R4<sub>0</sub>/ $\overline{SCK}$  pin, prescaler divide ratio, and transmit clock source as shown in table 7.

The write signal to the serial mode register controls the operating state of the serial interface.

The write signal to the serial mode register stops the serial data register and octal counter from accepting the transmit clock, and it also resets the octal counter to \$0 simultaneously. Therefore, when the serial interface is in the transfer state, the write signal causes the serial mode register to cease the data transmit and to set the serial interrupt request flag.

The contents of the serial mode register will be changed on the second instruction cycle after the serial mode register has been written to. Therefore, the STS instruction must be executed after the data in the serial mode register has been changed completely. The serial mode register will be reset to \$0 by MCU reset.

Table 7	Serial Mode Register	
SMR3	R4 <sub>0</sub> /SCK	
0	Used as R4 <sub>0</sub> port input/output pin	
1	Used as SCK input/output pin	

			Transmit Clock			
SMR2	SMR1	SMR0	R4₀/SCK Port	Clock Source	Prescaler Divide Ratio	System Clock Divide Ratio
0	0	0	SCK output	Prescaler	÷ 2048	÷ 4096
		1	SCK output	Prescaler	÷ 512	÷ 1024
	1	0	SCK output	Prescaler	÷ 128	÷ 256
		1	SCK output	Prescaler	÷ 32	÷ 64
1	0	0	SCK output	Prescaler	÷ 8	÷ 16
		1	SCK output	Prescaler	÷ 2	÷ 4
	1	0	SCK output	System clock	_	÷ 1
		1	SCK input	External clock	_	_

**Serial Data Register (SRL: \$006, SRU: \$007):** The 8-bit read/write serial data register consists of a low-order digit (SRL: \$006) and a high-order digit (SRU: \$007).

The data in the serial data register is output from the SO pin, from LSB to MSB, synchronously with the falling edge of the transmit clock signal. At the same time, external data is input from the SI pin to the serial data register, MSB first, synchronously with the rising edge of the transmit clock. Figure 10 shows the I/O timing chart of the transmit clock signal and the data.

The read/write operations of the serial data register should be performed after the completion of data transmit/receive. Otherwise the data may not be guaranteed.

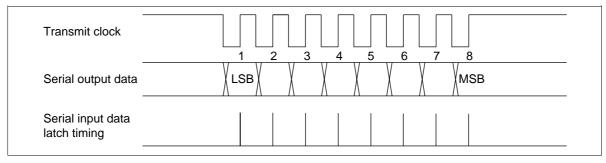


Figure 10 Serial Interface I/O Timing

**Serial Interrupt Request Flag (IFS: \$003, Bit 0):** The serial interrupt request flag will be set when the octal counter counts eight transmit clock signals, or when data transfer is discontinued by resetting the octal counter. Refer to table 8.

Table 8 Serial Interrupt Request Flag

IFS	Interrupt Request	
0	No	
1	Yes	

**Serial Interrupt Mask (IMS: \$003, Bit 1):** The serial interrupt mask masks the interrupt request. Refer to table 9.

**Table 9 Serial Interrupt Mask** 

IMS	Interrupt Request
0	Enabled
1	Disabled (masked)

**Selection and Change of the Operation Mode:** Table 10 shows the serial interface operation modes which are determined by a combination of the value in the port mode register and in the serial mode register.

Initialize the serial interface by a write signal to the serial mode register when the operation mode has changed.

**Table 10** Serial Interface Operation Mode

SMR3	PMR1	PMR0	Serial Interface Operating Mode
1	0	0	Clock continuous output mode
		1	Transmit mode
	1	0	Receive mode
		1	Transmit/receive mode

**Operating State of Serial Interface:** The serial interface has three operating states: the STS waiting state, transmit clock wait state, and transfer state, as shown in figure 11.

The STS waiting state is the initialization state of the serial interface. The serial interface enters this state in one of two ways: either by the operation mode changing through a change in the data in the port mode register, or by data being written into the serial mode register. In this state, the serial interface does not operate even if the transmit clock is applied. If the STS instruction is executed, the serial interface shifts to the transmit clock wait state.

In the transmit clock wait state the falling edge of the first transmit clock causes the serial interface to shift to the transfer state. The octal counter then counts up and the serial data register shifts simultaneously. As an exception, if the clock continuous output mode is selected, the serial interface stays in the transmit clock wait state while the transmit clock outputs continuously.

The octal counter becomes 000 again after 8 transmit clocks or the execution of the STS instruction, so the serial interface returns to the transmit clock wait state and the serial interrupt request flag is set simultaneously.

When the internal transmit clock is selected, the transmit clock output is triggered by the execution of the STS instruction, and stops after 8 clocks.

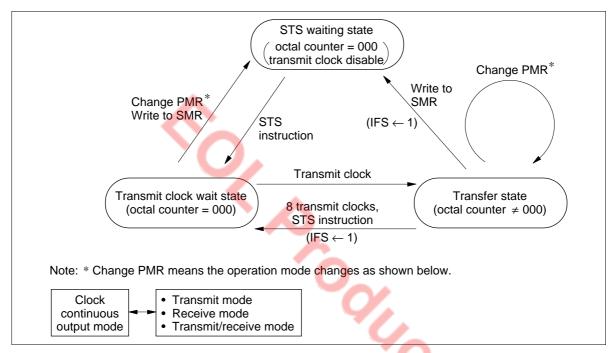


Figure 11 Serial Interface Operation State

**Transmit Clock Error Detection Example:** The serial interface functions abnormally when the transmit clock is disturbed by external noise. Transmit clock errors can be detected by the procedure shown in figure 12.

If more than 8 transmit clocks occur in the transfer state, the state of the serial interface shifts as follows: transfer state, transmit clock wait state, and transfer state. The serial interrupt flag should be reset before entering into the STS state by writing data to SMR. This procedure sets the IFS again.

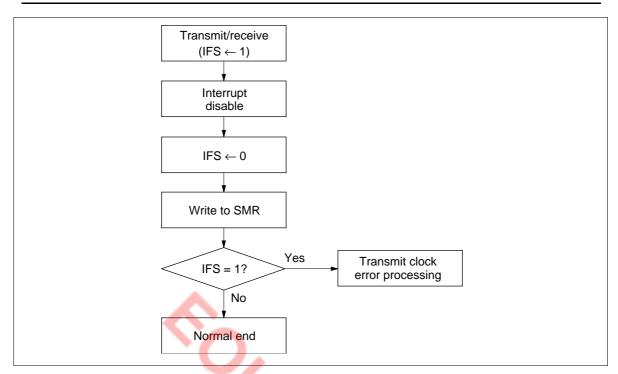


Figure 12 Transmit Clock Error Detection Example

#### **Timers**

The MCU contains a prescaler and two timer/counters (timers A and B). See figure 13. The prescaler is an 11-bit binary counter, timer A an 8-bit free-running timer, and timer B is an 8-bit auto-reload timer/event counter.

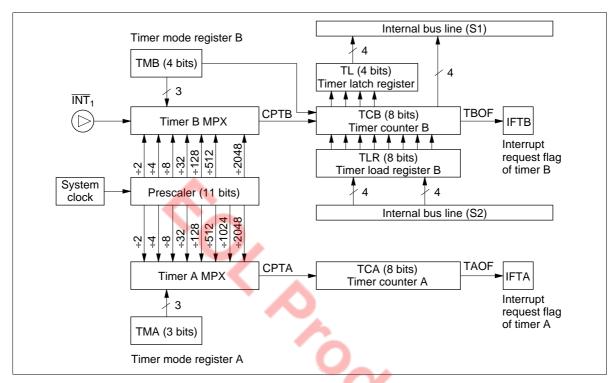


Figure 13 Timer/Counter Block Diagram

**Prescaler:** The input to the prescaler is the system clock signal. The prescaler is initialized to \$0000 by MCU reset, and it starts to count up with the system clock signal as soon as RESET input goes to logic 0. The prescaler keeps counting up except at MCU reset and stop mode. The prescaler provides clock signals to timer A, timer B, and the serial interface. The prescaler divide ratio is selected by timer mode register A (TMA), timer mode register B (TMB), or the serial mode register (SMR).

**Timer A Operation:** After timer A is initialized to \$00 by MCU reset, it counts up at every clock input signal. When the next clock signal is applied after timer A becomes \$FF, it generates an overflow and becomes \$00. This overflow causes the timer A interrupt request flag (IFTA: \$001, bit 2) to go to 1. This timer can function as an interval timer periodically generating overflow output at every 256th clock signal input.

The clock input signals to timer A are selected by timer mode register A (TMA: \$008).

**Timer B Operation:** Timer mode register B (TMB: \$009) selects the auto-reload function, input clock source, and the prescaler divide ratio of timer B. When the external event input is used as an input clock signal to timer B, select  $R3_3/\overline{INT}_1$  as  $\overline{INT}_1$  and set the external interrupt mask (IM1) to prevent an external interrupt request from occurring.

Timer B is initialized according to the data written into timer load register B by software. Timer B counts up at every clock input signal. When the next clock signal is applied to timer B after it is set to \$FF, it will generate an overflow output. In this case, if the autoreload function is selected, timer B is initialized according to the value of timer load register B. If it is not selected, timer B goes to \$00. The timer B interrupt request flag (IFTB: \$002, bit 0) will be set at this overflow output.

**Timer Mode Register A (TMA: \$008):** Timer mode register A is a 3-bit write-only register. The TMA controls the prescaler divide ratio of timer A clock input as shown in table 11. Timer mode register A is initialized to \$0 by MCU reset.

Table 11 Timer Mode Register A

TMA2	TMA1	TMA0	Prescaler Divide Ratio
0	0	0	÷ 2048
		1	÷ 1024
	1	0	÷ 512
		1	÷ 128
1	0	0	÷ 32
		1	÷ 8
	1	0	÷ 4
		1	÷ 2

**Timer Mode Register B (TMB: \$009):** Timer mode register B (TMB) is a 4-bit write-only register which selects the auto-reload function, the prescaler divide ratio, and the source of the clock input signal, as shown in table 12. Timer mode register B is initialized to \$0 by MCU reset.

The operation mode of timer B changes at the second instruction cycle after timer mode register B is written to. Timer B should be initialized by writing data into timer load register B after the contents of TMB are changed. The configuration and function of timer mode register B is shown in figure 14.

Table 12 Timer Mode Register B

TMB3	Auto-Reload Function
0	No
1	Yes

HD	404	01	<b>9R</b>	Se	riec

TMB2	TMB1	TMB0	Prescaler Divide Ratio, Clock Input Source
0	0	0	÷ 2048
		1	÷ 512
	1	0	÷ 128
		1	÷ 32
1	0	0	÷ 8
		1	÷ 4
	1	0	÷ 2
		1	ĪNT₁ (external event input)

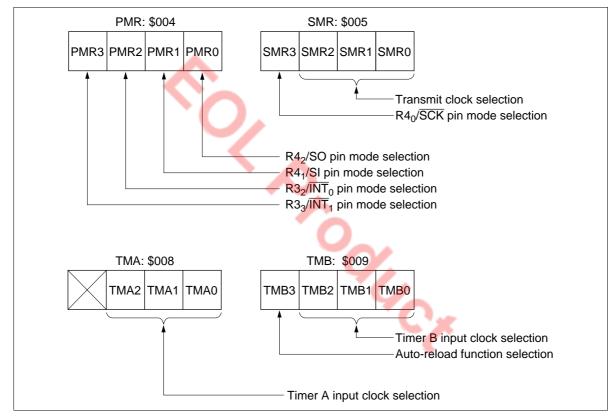


Figure 14 Mode Register Configuration and Function

**Timer B (TCBL: \$00A, TCBU: \$00B, TLRL: \$00A, TLRU: \$00B):** Timer B consists of an 8-bit write-only timer load register, and an 8-bit read-only timer counter. Each of them has a low-order digit (TCBL: \$00A, TLRL: \$00A) and a high-order digit (TCBU: \$00B, TLRU: \$00B). (Refer to figure 2.)

Timer counter B can be initialized by writing data into timer load register B. Write the low-order digit first, and then the high-order digit. The timer counter is initialized when the high-order digit is written. The timer load register is initialized to \$00 by the MCU reset.

The counter value of timer B can be obtained by reading timer counter B. In this case, read the high-order digit first, and then the low-order digit. The count value of the low-order digit is latched at the time when the high-order digit is read.

**Timer A Interrupt Request Flag (IFTA: \$001, Bit 2):** The timer A interrupt request flag is set by the overflow output of timer A (table 13).

Table 13 Timer A Interrupt Request Flag

IFTA	Interrupt Request
0	No
1	Yes

**Timer A Interrupt Mask (IMTA: \$001, Bit 3):** The timer A interrupt mask prevents an interrupt request from being generated by the timer A interrupt request flag (table 14).

Table 14 Timer A Interrupt Mask

IMTA	Interrupt Request
0	Enabled
1	Disabled (masked)

**Timer B Interrupt Request Flag (IFTB: \$002, Bit 0):** The timer B interrupt request flag is set by the overflow output of timer B (table 15).

Table 15 Timer B Interrupt Request Flag

IFTB	Interrupt Request	9,
0	No	
1	Yes	*C-

**Timer B Interrupt Mask (IMTB: \$002, Bit 1):** The timer B interrupt mask prevents an interrupt request from being generated by the timer B interrupt request flag (table 16).

Table 16 Timer B Interrupt Mask

IMTB	Interrupt Request		
0	Enabled		
1	Disabled (masked)		

#### Input/Output

The MCU has 58 I/O pins, 32 standard and 26 high voltage. One of three circuit types can be selected by the mask option for each standard pin: CMOS, with pull-up MOS, and without pull-up MOS (NMOS open drain); and one of two circuit types can be selected for each high-voltage pin: with pull-down MOS and without pull-down MOS (PMOS open drain). Since the pull-down MOS is connected to the internal  $V_{disp}$  line, the  $RA_1/V_{disp}$  pin must be selected as  $V_{disp}$  via the mask option when the option with pull-down MOS is selected for at least one high-voltage pin. See table 17 for I/O pin circuit types.

When every input/output pin is used as an input pin, the mask option and output data must be selected in the manner specified in table 18.

**Output Circuit Operation of With Pull-Up MOS Standard Pins:** In the standard pin option with pull-up MOS, the circuit shown in figure 15 is used to shorten the rise time of the output.

When the MCU executes an output instruction, it generates a write pulse to the R port addressed by this instruction. This pulse will switch the PMOS (B) on and shorten the rise time. The write pulse keeps the PMOS in the on state for one-eighth of the instruction cycle time. While the write pulse is 0, a high output level is maintained by the pull-up MOS (C).

When the HLT signal becomes 0 in the stop mode, MOS (A), (B), and (C) turn off.

**D Port:** I/O port D has 16 discrete I/O pins, each of which can be addressed independently. It can be set/reset through the SED/RED and SEDD/REDD instructions, and can be tested through the TD and TDD instructions. See tables 17 and 18 for the classification of standard pin, high-voltage pin, and the I/O pin circuit types.

**R Ports:** The eleven R ports are composed of 36 I/O pins and 6 input-only pins. Data is input through the LAR and LBR instructions and output through the LRA and LRB instructions. The MCU will not be affected by writing into the input-only and/or non-existing ports, while invalid data will be read when the output-only and/or non-existing ports are read.

The R3<sub>2</sub>, R3<sub>3</sub>, R4<sub>0</sub>, R4<sub>1</sub>, and R4<sub>2</sub> pins are multiplexed with the  $\overline{INT}_0$ ,  $\overline{INT}_1$ ,  $\overline{SCK}$ , SI, and SO pins, respectively. See tables 17 and 18 for the classification of standard pins, high-voltage pins and selectable circuit types of these I/O pins.

**Unused I/O Pins:** If unused I/O pins are left floating, the LSI may malfunction because of noise. The I/O pins should be fixed as follows to prevent malfunction.

High-voltage pins: Select without pull-down MOS (PMOS open drain) via the mask option and connect to  $V_{\text{CC}}$  on the printed circuit board.

Standard pins: Select without pull-up MOS (NMOS open drain) via the mask option and connect to GND on the printed circuit board.

 $R4_0\sqrt{SCK}$  and  $R4_2/SO$  should be used as  $R4_0$  and  $R4_2$  by the serial mode register and port mode register, respectively.

Table 17 I/O Pin Circuit Types

## **Standard Pins**

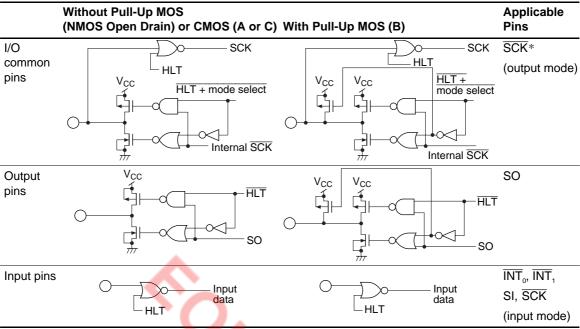
	Without Pull-Up MOS (NMOS Open Drain) (A)	With Pull-Up MOS (B)	CMOS (C)	Applicable Pins
I/O		HIT → Input		D <sub>0</sub> –D <sub>3</sub> ,
common	HLT Input data	data	HLT - Input data	R3 <sub>0</sub> -R3 <sub>3</sub> ,
pins		pulse	V <sub>CC</sub>	R4 <sub>0</sub> –R4 <sub>3</sub> ,
	→ <del>HLT</del>	HLT	HLT HLT	R5 <sub>0</sub> –R5 <sub>3</sub> ,
	Output	Output		R6 <sub>0</sub> -R6 <sub>3</sub> ,
	<del>////</del> data	data	Outpu data	t R7 <sub>0</sub> –R7 <sub>3</sub> ,
				R8 <sub>0</sub> -R8 <sub>3</sub>
Input pins		V <sub>CC</sub>	_	R9 <sub>0</sub> -R9 <sub>3</sub>
	HLT — Input data	HLT - Input data		

## **High Voltage Pins**

	Without Pull-Down MOS (PMOS Open Drain) (D)	With Pull-Up MOS (E)	Applicable Pins
I/O	Vçc	Vçc	D <sub>4</sub> –D <sub>15</sub> ,
common pins	THE THE	THET HET	R0 <sub>0</sub> -R0 <sub>3</sub> ,
piris	Output	Output	R1 <sub>0</sub> -R1 <sub>3</sub> ,
		V <sub>cc</sub> +}H	R2 <sub>0</sub> -R2 <sub>3</sub>
	HLT - Input data	V <sub>disp</sub> HLT - Input data	
Input pins	HLT Input data	HLT Input data	RA <sub>0</sub>
Input pins	HLT Input data	-	RA <sub>1</sub>

29

#### **Standard Pins**



Notes: In the stop mode, HLT is 0, HLT is 1 and I/O pins are in high impedance.

Table 18 Data Input from Common Input/Output Pins

I/O Pin Circuit Type		Input Possible	Input Pin State
Standard pins	CMOS	No	_
	Without pull-up MOS (NMOS open drain)		1
	With pull-up MOS	Yes	1
High voltage pins	Without pull-down MOS (PMOS open drain)	Yes	0
	With pull-down MOS	Yes	0

<sup>\*</sup> If the MCU is interrupted by the serial interface in the external clock input mode, the SCK terminal becomes input only.

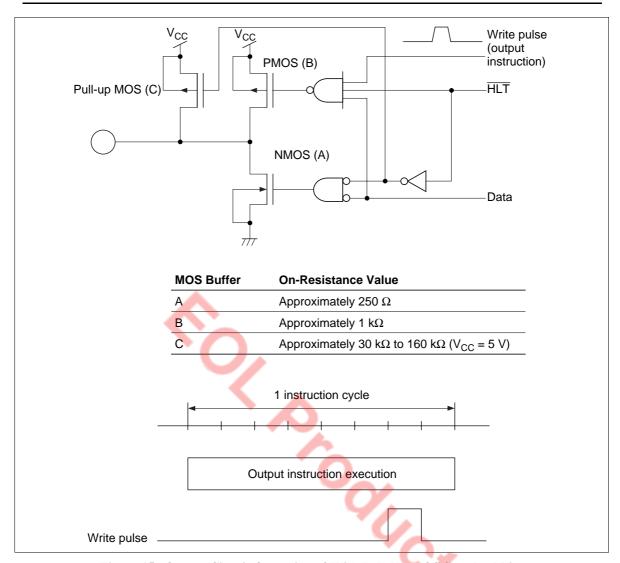


Figure 15 Output Circuit Operation of With Pull-Up MOS Standard Pins

#### Reset

Pulling the RESET pin high resets the MCU. At power-on or when cancelling the stop mode, the reset must satisfy  $t_{RC}$  for the oscillator to stabilize. In all other cases, at least two instruction cycles are required for the MCU to be reset.

Table 19 shows the components initialized by MCU reset, and the status of each.

**Table 19** Initial Values After MCU Reset

Item			Initial Value by MCU Reset	Contents
Program counter (PC)			\$0000	Execute program from the top of ROM address
Status flag (ST)			1	Enable branching with conditional branch instructions
Stack pointer (SP)			\$3FF	Stack level is 0
I/O pins, output register	Standard pins	(A) Without pull-up MOS	1	Enable to input
		(B) With pull-up MOS	1	Enable to input
		(C) CMOS	1	_
	High-voltage pins	(D) Without pull- down MOS	0	Enable to input
		(E) With pull- down MOS	0	Enable to input
Interrupt flags	Interrupt enable flag (IE)		0	Inhibit all interrupts
	Interrupt request flag (IF)		0	No interrupt request
	Interrupt mask (IM)		1	Mask interrupt request
Mode registers	Port mode register (PMR)		0000	See Port Mode Register section
	Serial mode register (SMR)		0000	See Serial Mode Register section
	Timer mode register A (TMA)		000	See Timer Mode Register A section
	Timer mode register B (TMB)		0000	See Timer Mode Register B section
Timer/counters	Prescaler		\$000	_
	Timer counter A (TCA)		\$00	
	Timer counter B (TCB)		\$00	_
	Timer load register (TLR)		\$00	_
	Octal counter		000	

			HD404019R Series
Item		After MCU Reset to Recover from Stop Mode	After MCU Reset to Recover from Other Modes
Carry flag	(CA)	The contents of the items before MCU reset are not retained. It is necessary to initialize them by software.	The contents of the items before MCU reset are not retained. It is necessary to initialize them by software.
Accumulator	(A)	_	
B register	(B)		
W register	(W)	_	
X/SPX register	(X/SPX)		
Y/SPY register	(Y/SPY)		
Serial data register	(SR)		
RAM		The contents of RAM before MCU reset (just before STOP instruction) are retained	Same as above for RAM

### **Internal Oscillator Circuit**

Figure 16 outlines the internal oscillator circuit. A crystal oscillator or ceramic oscillator can be selected as the oscillator type. Refer to table 20 to select the oscillator type. In addition, see figure 17 for the layout of the crystal or ceramic oscillator.

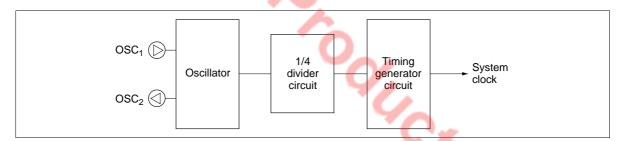


Figure 16 Internal Oscillator Circuit

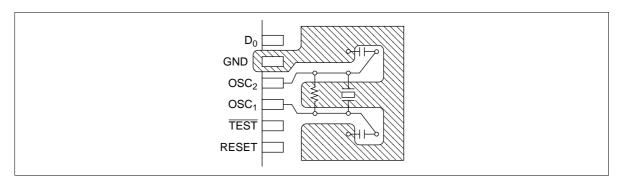


Figure 17 Layout of Crystal or Ceramic Oscillator

**Table 20** Examples of Oscillator Circuits

#### **Circuit Configuration Circuit Constants** External clock operation OSC<sub>1</sub> Oscillator (OSC<sub>1</sub>, OSC<sub>2</sub>) Open OSC<sub>2</sub> Ceramic oscillator Ceramic oscillator C<sub>1</sub> (OSC<sub>1</sub>, OSC<sub>2</sub>) OSC<sub>1</sub> CSA4.00MG (Murata) Ceramic $R_f$ : 1 M $\Omega$ ±20% oscillator C<sub>1</sub>: 30 pF ±20% OSC<sub>2</sub> C<sub>2</sub>: 30 pF ±20% **GND** $R_f$ : 1 M $\Omega$ ±20% Crystal oscillator (OSC<sub>1</sub>, OSC<sub>2</sub>) OSC<sub>1</sub> C<sub>1</sub>: 10 pF to 22 pF ±20% Crystal C<sub>2</sub>: 10 pF to 22 pF ±20% Crystal: Equivalent circuit shown OSC<sub>2</sub> at bottom left **GND** C<sub>o</sub>: 7 pF max. AT-cut parallel $R_s$ : 100 $\Omega$ max. resonance crystal f: 1.0 MHz to 4.5 MHz 7000 OSC<sub>2</sub> $C_0$

- Notes: 1. The circuit parameters written above are recommended by the crystal or ceramic oscillator manufacturer. The circuit parameters are affected by the crystal, ceramic resonator, and the floating capacitance when designing the board.
  - When using the resonator, consult with the crystal or ceramic oscillator manufacturer to determine the circuit parameters.
  - 2. Wiring among OSC<sub>1</sub>, OSC<sub>2</sub>, and other elements should be as short as possible, and avoid crossing other wires. Refer to the recommended layout of the crystal and ceramic oscillator. Refer to figure 17.

### **Operating Modes**

The MCU has two low-power dissipation modes, standby mode and stop mode (table 21). Figure 18 is a mode transition diagram for these modes.

**Standby Mode:** Executing the SBY instruction puts the MCU into standby mode. In standby mode, the oscillator circuit is active, and the interrupts, timer/counters, and serial interface remain working. On the other hand, the CPU stops since the clock related to the instruction execution stops. Registers, RAM, and I/O pins retain the states they were in just before the MCU went into standby mode.

Table 21	Low-Power	Dissipation	Modes
----------	-----------	-------------	-------

Condition	Standby Mode	Stop Mode
Instruction	SBY instruction	STOP instruction
Oscillator circuit	Active	Stopped
Instruction execution	Stopped	Stopped
Registers, flags	Retained	Reset*1
Interrupt function	Active	Stopped
RAM	Retained	Retained
Input/output pins	Retained*2	High impedance
Timer/counters, serial interface	Active	Stopped
Cancellation method	RESET input, interrupt request	RESET input

- Notes: 1. The MCU recovers from the stop mode by RESET input. Refer to table 19 for the contents of flags and registers.
  - 2. When I/O circuits are active, an I/O current may flow in the standby mode, depending on the state of the I/O pins. This is an additional current added to the standby mode current dissipation.

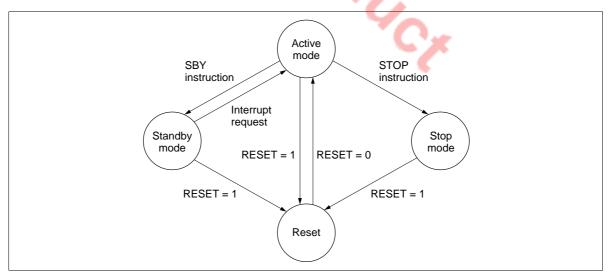


Figure 18 MCU Operating Mode Transition

Standby mode may be cancelled by inputting RESET or by asserting an interrupt request. In the former case the MCU is reset. In the later case, the MCU becomes active and executes the next instruction following the SBY instruction. If the interrupt enable flag is 1 when an interrupt request is asserted, the interrupt is executed, while if it is 0, the interrupt request is put on hold and normal instruction execution continues.

Figure 19 shows the flowchart of the standby mode.

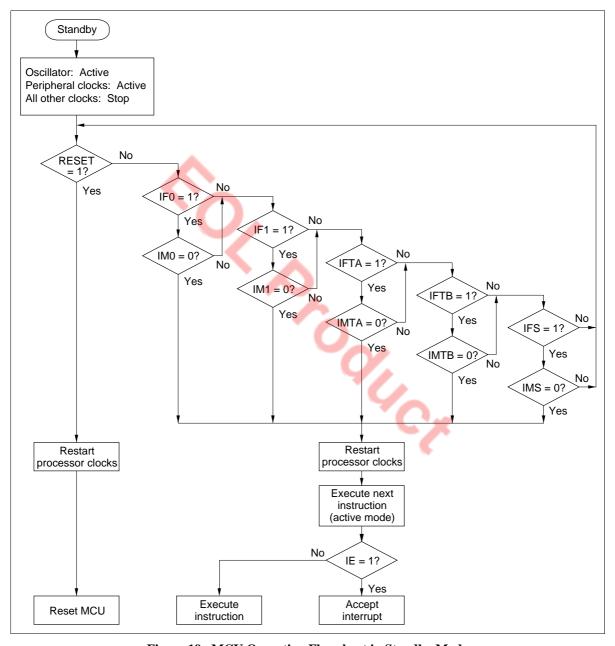


Figure 19 MCU Operating Flowchart in Standby Mode

**Stop Mode:** Executing the STOP instruction brings the MCU into stop mode, in which the oscillator circuit and every function of the MCU stop.

The stop mode may be cancelled by resetting the MCU. At this time, as shown in figure 20, reset input must be applied for at least  $t_{RC}$  for oscillation to be stabilized. (Refer to the AC Characteristics table.) After the stop mode is cancelled, RAM retains the state it was in just before the MCU went into stop mode, but the accumulator, B register, W register, X/SPX registers, Y/SPY registers, carry flag, and serial data register will not retain their contents.

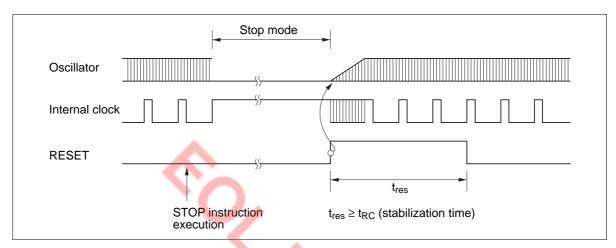


Figure 20 Timing of Stop Mode Cancellation

CACA

# **PROM Mode Pin Description**

Table 22 describes the pin functions in PROM mode.

Table 22 PROM Mode Signals

Pin Number	•		MCU Mode		PROM Mod	le
DC-64S, DP-64S	FP-64B	FP-64A	Symbol	I/O	Symbol	I/O
1	59	57	D <sub>11</sub>	I/O	V <sub>cc</sub>	
2	60	58	D <sub>12</sub>	I/O		
3	61	59	D <sub>13</sub>	I/O		
4	62	60	D <sub>14</sub>	I/O		
5	63	61	D <sub>15</sub>	I/O		
6	64	62	R0 <sub>0</sub>	I/O	A <sub>1</sub>	I
7	1	63	R0₁	I/O	A <sub>2</sub>	1
8	2	64	R0 <sub>2</sub>	I/O	$A_3$	1
9	3	1	R0 <sub>3</sub>	I/O	A <sub>4</sub>	I
10	4	2	R1 <sub>0</sub>	I/O	A <sub>5</sub>	1
11	5	3	R1 <sub>1</sub>	I/O	A <sub>6</sub>	1
12	6	4	R1 <sub>2</sub>	I/O	A <sub>7</sub>	1
13	7	5	R1 <sub>3</sub>	I/O	A <sub>8</sub>	1
14	8	6	R2 <sub>0</sub>	I/O	A <sub>o</sub>	1
15	9	7	R2₁	I/O	A <sub>10</sub>	1
16	10	8	R2 <sub>2</sub>	I/O	A <sub>11</sub>	I
17	11	9	R2 <sub>3</sub>	I/O	A <sub>12</sub>	1
18	12	10	RA <sub>o</sub>	1	V <sub>cc</sub>	
19	13	11	RA <sub>1</sub> /V <sub>disp</sub>	ı		
20	14	12	R3 <sub>0</sub>	I/O	A <sub>13</sub>	1
21	15	13	R3₁	I/O	A <sub>14</sub>	1
22	16	14	R3 <sub>2</sub> /INT <sub>0</sub>	I/O		
23	17	15	R3 <sub>3</sub> /ĪNT <sub>1</sub>	I/O		
24	18	16	R5 <sub>0</sub>	I/O		
25	19	17	R5₁	I/O		
26	20	18	R5 <sub>2</sub>	I/O		
27	21	19	R5 <sub>3</sub>	I/O		
28	22	20	R6 <sub>0</sub>	I/O		
29	23	21	R6₁	I/O		

30 24 22 Re 31 25 23 Re 32 26 24 V <sub>c</sub> 33 27 25 Re	6 <sub>2</sub> I. 6 <sub>3</sub> I.	/O /O	Symbol V <sub>cc</sub>	I/O
31 25 23 Ref 32 26 24 V <sub>c</sub> 33 27 25 Ref	6 <sub>3</sub> I	/O	Voo	
32 26 24 V <sub>c</sub> 33 27 25 R	cc	,	Voc	
33 27 25 R			Vaa	
	4 <sub>0</sub> /SCK	10	- 00	
34 28 26 R4		/O	O <sub>4</sub>	I/O
51 20 20 10	.4₁/SI I.	/O	O <sub>5</sub>	I/O
35 29 27 R	4 <sub>2</sub> /SO I	/O	O <sub>6</sub>	I/O
36 30 28 R	.4 <sub>3</sub> I,	/O	O <sub>7</sub>	I/O
37 31 29 R	7 <sub>0</sub> I,	/O	CE	1
38 32 30 R	7 <sub>1</sub> I	/O	OE	I
39 33 31 R	7 <sub>2</sub> I	/O		
40 34 <mark>32</mark> R	7 <sub>3</sub> I	/O	O <sub>4</sub>	I/O
41 35 <b>33</b> R8	8 <sub>0</sub> I	/O	O <sub>3</sub>	I/O
42 36 <b>3</b> 4 R8	8 <sub>1</sub> I	/O	O <sub>2</sub>	I/O
43 37 35 R	8 <sub>2</sub> I	/O	O <sub>1</sub>	I/O
44 38 36 R8	8 <sub>3</sub> I	/O	O <sub>0</sub>	I/O
45 39 37 RS	9 <sub>0</sub> I		V <sub>PP</sub>	
46 40 38 R	9 <sub>1</sub> I		$A_9$	1
47 41 39 Rs	9 <sub>2</sub> I		$\overline{M}_{\scriptscriptstyle{0}}$	I
48 42 40 RS	9 <sub>3</sub> I		$\overline{M}_{\scriptscriptstyle{1}}$	I
49 43 41 RI	ESET	2	RESET	I
50 44 42 TE	EST		TEST	I
51 45 43 O	SC₁ I	0		
52 46 44 O	SC <sub>2</sub>		<b>~</b>	
53 47 45 G	ND		GND	
54 48 46 D <sub>c</sub>	o I,	/O	O <sub>0</sub>	I/O
55 49 47 D <sub>1</sub>	I, I,			I/O
56 50 48 D <sub>2</sub>	, I,	/O	O <sub>2</sub>	I/O
57 51 49 D <sub>2</sub>				I/O
58 52 50 D <sub>2</sub>	I,	/O		
59 53 51 D <sub>e</sub>	5 I,	/O		

Pin Number			MCU Mode		PROM Mod	PROM Mode		
DC-64S, DP-64S	FP-64B	FP-64A	Symbol	I/O	Symbol	I/O		
60	54	52	D <sub>6</sub>	I/O				
61	55	53	D <sub>7</sub>	I/O				
62	56	54	D <sub>8</sub>	I/O				
63	57	55	D <sub>9</sub>	I/O				
64	58	56	D <sub>10</sub>	I/O	V <sub>cc</sub>			

Notes: 1. I/O: Input/output pins

> I: Input pins O: Output pins

2. Connect each pair of O<sub>4</sub>, O<sub>3</sub>, O<sub>2</sub>, O<sub>1</sub>, and O<sub>0</sub>. Hitachi supplies the socket adapter on which these pairs are internally connected.



### **Programmable ROM Operation**

The on-chip PROM of HD4074019 and HD407L4019 are programmed in PROM mode. The PROM mode is set by pulling  $\overline{\text{TEST}}$ ,  $\overline{M}_0$ , and  $\overline{M}_1$  low, and RESET high as shown in figure 21. In PROM mode, the MCU does not operate. It can be programmed like a standard 27256 EPROM using a standard PROM programmer and a 64-to-28-pin socket adapter. Table 24 lists the recommended PROM programmers and socket adapters.

Since the instruction of the HMCS400 series consists of 10 bits, the HMCS400-series microcom puter incorporates a conversion circuit used as a general-purpose PROM programmer. By this circuit, an instruction is read or programmed using 2 addresses, the low-order 5 bits and the high-order 5 bits. For example, if 8 kwords of an on-chip PROM are programmed by a general purpose PROM programmer, 16 kbytes of addresses (\$0000 to \$3FFF) should be specified.

#### **Programming and Verification**

The HD4074019 and HD407L4019 can be programmed at high-speed without causing voltage stress or affecting data reliability.

Table 23 shows how programming and verification modes are selected.

#### **Erasing**

PROMs with ceramic window packages can be erased by ultraviolet light. All erased bits become 1s.

The erasing specifications are as follows: ultraviolet (UV) light with wavelength 2537 Å with a minimum irradiation of 15 W sec/cm<sup>2</sup>. These conditions are satisfied by exposing the LSI to a 12,000- $\mu$ W/cm<sup>2</sup> UV source for 15 to 20 minutes at a distance of 1 inch.

#### **Precautions**

- Addresses \$0000 to \$7FFF should be specified if the PROM is programmed by a PROM programmer.
   Note that the plastic package type cannot be erased and reprogrammed.
   (Only ceramic window packages can be erased and reprogrammed.)
- 2. Make sure that the PROM programmer, socket adapter, and LSI match properly. Using the wrong programmer for the socket adapter may cause an overvoltage and damage the LSI. Make sure that the LSI is firmly fixed in the socket adapter, and that the socket adapter is firmly fixed to the programmer.
- 3. The PROM should be programmed with  $V_{PP}=12.5~V$ . Other PROMs use 21 V. If 21 V is applied to the HD4074019 and HD407L4019, the LSI may be permanently damaged. 12.5 V is the voltage for  $V_{PP}$  of Intel's 27256.

**Table 23 PROM Modes Selection** 

Pin CE OE Mode  $\mathbf{V}_{\mathsf{PP}}$ O<sub>0</sub> to O<sub>7</sub>  $V_{PP}$ Programming Low High Data input Verify High Low Data output  $V_{PP}$ Programming High impedance High High  $V_{PP}$ inhibited

Table 24 Recommended PROM Programmers and Socket Adapters

PROM Programmer\* Socket Adapter

_			•	
Maker	Type Name	Package Type	Type Name	Maker
DATA I/O	280	DP-64S	HS409ESS11H	Hitachi
	201	DC-64S		
	29B + UniPak2B	FP-64B	HS409ESF01H	
	S22	FP-64A	HS409ESH01H	
AVAL DATA Corp.	PKW-1000	DP-64S	HS409ESS21H	Hitachi
	PKW-1100	DC-64S		
	PKW-1600	FP-64B	HS409ESF01H	
	PKW-3100	FP-64A	HS409ESH01H	

Note: \* Since the address pins of the HD4074019 and HD407L4019 are high voltage pins, errors may occur in device insertion tests if a PROM programmer other than those listed above is used.

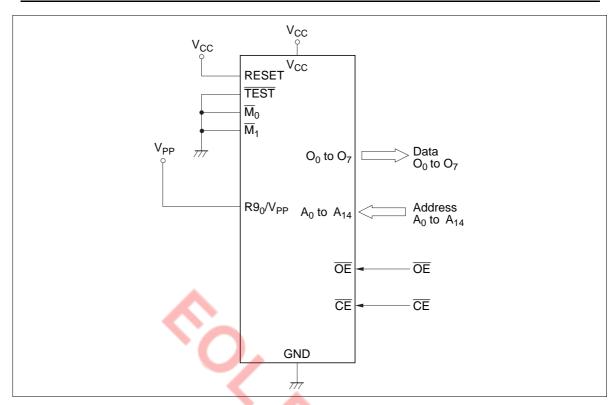


Figure 21 PROM Mode Function Diagram

CX.

### **Addressing Modes**

#### **RAM Addressing Modes**

As shown in figure 22, the MCU has three RAM addressing modes: register indirect addressing, direct addressing, and memory register addressing.

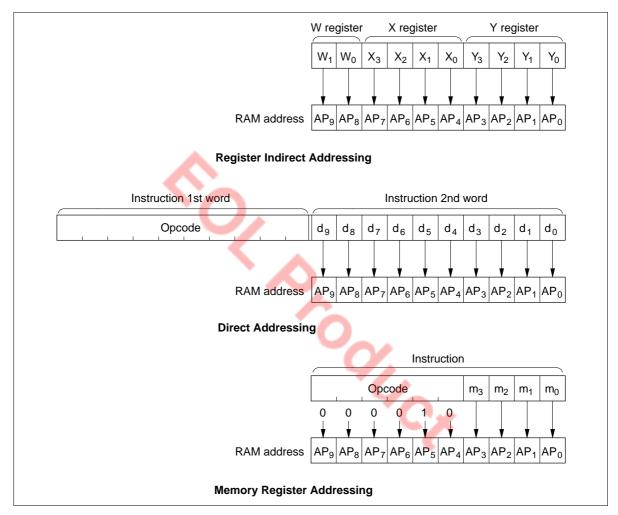


Figure 22 RAM Addressing Modes

**Register Indirect Addressing Mode:** The W register, X register, and Y register contents (10 bits) are used as the RAM address.

**Direct Addressing Mode:** A direct addressing instruction consists of two words, with the word (10 bits) following the opcode used as the RAM address.

**Memory Register Addressing Mode:** The memory registers (16 digits from \$020 to \$02F) are accessed by executing the LAMR and XMRA instructions.

#### **ROM Addressing Modes and the P Instruction**

The MCU has four kinds of ROM addressing modes as shown in figure 23.

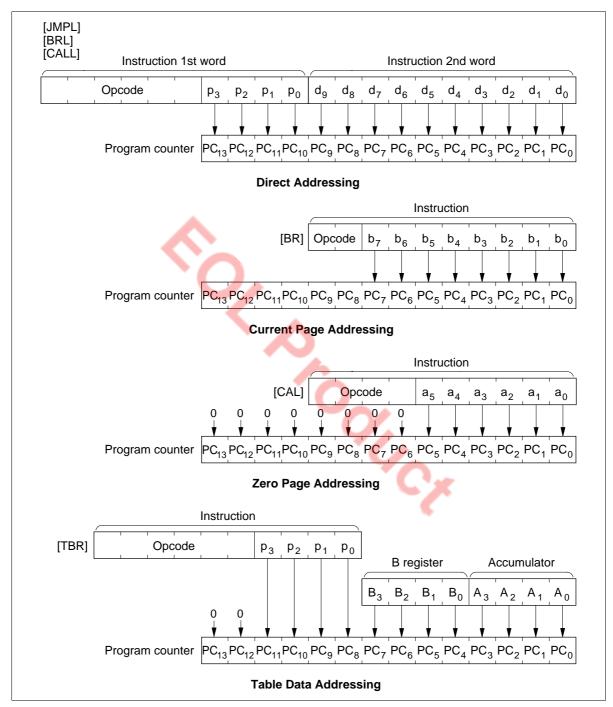


Figure 23 ROM Addressing Modes

**Direct Addressing Mode:** The program can branch to any address in ROM memory space by executing the JMPL, BRL, or CALL instruction. These instructions replace the 14 program counter bits ( $PC_{13}$  to  $PC_0$ ) with 14-bit immediate data.

**Current Page Addressing Mode:** The MCU has 8 pages of ROM with 256 words per page. By executing the BR instruction, the program can branch to an address on the current page. This instruction replaces the low-order eight bits of the program counter ( $PC_7$  to  $PC_0$ ) with 8-bit immediate data.

When the BR instruction is on a page boundary (256n + 255) (figure 24), executing it transfers the PC contents to the next page, due to the hardware architecture. Consequently, the program branches to the next page when the BR instruction is used on a page boundary. The HMCS400-series cross macroassembler has an automatic paging facility for ROM pages.

**Zero-Page Addressing Mode:** By executing the CAL instruction, the program can branch to the zero-page subroutine area, which is located at \$0000 to \$003F. When the CAL instruction is executed, 6 bits of immediate data are placed in the low-order six bits of the program counter ( $PC_5$  to  $PC_0$ ) and 0s are placed in the high-order eight bits ( $PC_{13}$  to  $PC_6$ ).

**Table Data Addressing Mode:** By executing the TBR instruction, the program can branch to the address determined by the contents of the 4-bit immediate data, accumulator, and B register.

**P Instruction:** ROM data addressed by table data addressing can be referenced by the P instruction (figure 25). When bit 8 in the referred ROM data is 1, 8 bits of ROM data are written into the accumulator and B register. When bit 9 is 1, 8 bits of ROM data are written into the R1 and R2 port output registers. When both bits 8 and 9 are 1, ROM data are written into the accumulator and B register, and also to the R1 and R2 port output registers at the same time.

SOLICA

The P instruction has no effect on the program counter.

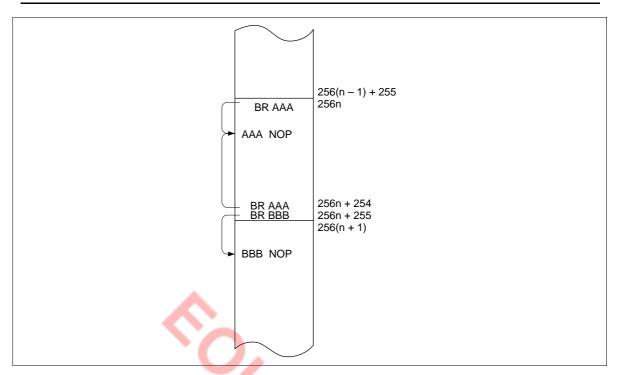


Figure 24 BR Instruction Branch Destination on a Page Boundary

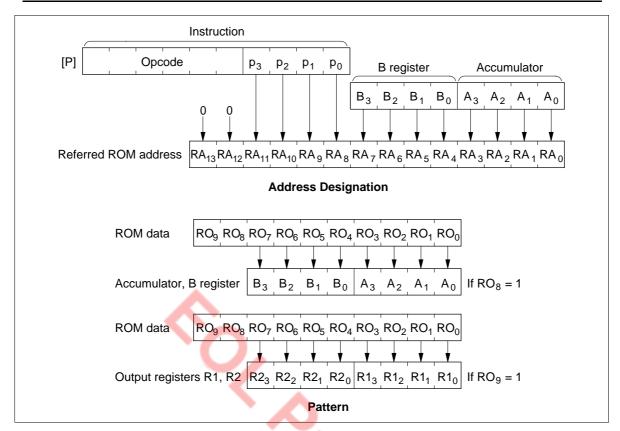


Figure 25 P Instruction

### **Absolute Maximum Ratings**

Item	Symbol	Value	Unit	Notes
Supply voltage	V <sub>cc</sub>	-0.3 to +7.0	V	
Programming voltage	V <sub>PP</sub>	-0.3 to +14	V	10
Pin voltage	V <sub>T</sub>	$-0.3$ to $V_{cc} + 0.3$	V	1
		$V_{\rm CC} - 45 \text{ to } V_{\rm CC} + 0.3$	V	2
Total permissible input current	$\Sigma I_{\circ}$	50	mA	3
Maximum input current	I <sub>o</sub>	15	mA	5, 6
Maximum output current	-I <sub>o</sub>	4	mA	6, 7
		6	mA	7, 8
		30	mA	7, 9
Total permissible output current	$-\Sigma I_{\circ}$	150	mA	4
Operating temperature	T <sub>opr</sub>	-20 to +75	°C	
Storage temperature	T <sub>stg</sub>	–55 to +125	°C	

Notes: Permanent damage may occur if these absolute maximum ratings are exceeded. Normal operation should be under the conditions of the electrical characteristics. If these conditions are exceeded, it may cause a malfunction or affect the reliability of the LSI.

All voltages are with respect to GND.

- 1. Standard pins.
- 2. High voltage pins.
- 3. Total permissible input current is the total sum of input currents which flow in from all I/O pins to GND simultaneously.
- 4. Total permissible output current is the total sum of the output currents which flow out from  $V_{cc}$  to all I/O pins simultaneously.
- 5. Maximum input current is the maximum amount of input current from each I/O pin to GND.
- 6. D<sub>0</sub> to D<sub>3</sub> and R3 to R8.
- 7. Maximum output current is the maximum amount of output current from V<sub>cc</sub> to each I/O pin.
- 8. R0 to R2.
- 9. D<sub>4</sub> to D<sub>15</sub>.
- 10. Applied to HD4074019 and HD407L4019.

### **Electrical Characteristics**

#### **DC** Characteristics

 $\begin{array}{l} (HD404019R; \ V_{CC} = 3.5 \ V \ to \ 6 \ V, \ GND = 0 \ V, \ V_{disp} = V_{CC} - 40 \ V \ to \ V_{CC}, \ Ta = -20^{\circ}C \ to \ +75^{\circ}C \\ HD4014019R; \ V_{CC} = 2.7 \ V \ to \ 6 \ V, \ GND = 0 \ V, \ V_{disp} = V_{CC} - 40 \ V \ to \ V_{CC}, \ Ta = -20^{\circ}C \ to \ +75^{\circ}C \\ HD4074019; \ V_{CC} = 4.5 \ V \ to \ 5.5 \ V, \ GND = 0 \ V, \ V_{disp} = V_{CC} - 40 \ V \ to \ V_{CC}, \ Ta = -20^{\circ}C \ to \ +75^{\circ}C \\ HD40714019; \ V_{CC} = 3.0 \ V \ to \ 5.5 \ V, \ GND = 0 \ V, \ V_{disp} = V_{CC} - 40 \ V \ to \ V_{CC}, \ Ta = -20^{\circ}C \ to \ +75^{\circ}C \\ unless otherwise specified) \end{array}$ 

Item	Symbol	Pin	Min	Тур	Max	Unit	Test Conditions	Note
Input high voltage	V <sub>IH</sub>	$\begin{array}{c} \text{RESET,} \\ \overline{\text{SCK}}, \\ \overline{\text{INT}_0}, \overline{\text{INT}_1} \end{array}$	0.8 V <sub>cc</sub>	_	V <sub>cc</sub> + 0.3	V	HD404019R, HD4074019	
			0.9 V <sub>CC</sub>	_	V <sub>CC</sub> + 0.3	٧	HD40L4019R	
			0.8 V <sub>cc</sub>	_	V <sub>CC</sub> + 0.3	٧	HD407L4019: V <sub>CC</sub> = 4.5 V to 5.5 V	
			0.9 V <sub>cc</sub>	_	V <sub>cc</sub> + 0.3	V	HD407L4019	
		SI	0.7 V <sub>cc</sub>	_	V <sub>cc</sub> + 0.3	V	HD404019R, HD4074019	
			0.8 V <sub>cc</sub>	<b>—</b>	V <sub>cc</sub> + 0.3	٧	HD40L4019R	
			0.7 V <sub>cc</sub>	_	V <sub>cc</sub> + 0.3	V	HD407L4019: V <sub>CC</sub> = 4.5 V to 5.5 V	
			0.9 V <sub>cc</sub>		V <sub>cc</sub> + 0.3	٧	HD407L4019	
		OSC <sub>1</sub>	V <sub>cc</sub> -0.5	-	V <sub>cc</sub> + 0.3	V	HD404019R, HD4074019, HD407L4019	
			V <sub>cc</sub> -0.3	_	$V_{cc} + 0.3$	V	HD40L4019R	
Input low voltage	V <sub>IL</sub>	$\begin{array}{c} \text{RESET,} \\ \overline{\text{SCK}}, \\ \overline{\text{INT}_0}, \overline{\text{INT}_1} \end{array}$	-0.3	_	0.2 V <sub>cc</sub>	V	HD404019R, HD4074019	
			-0.3	_	0.1 V <sub>cc</sub>	٧	HD40L4019R	
			-0.3	_	$0.2~\mathrm{V_{cc}}$	٧	HD407L4019: $V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$	
			-0.3	_	$0.1~V_{\rm cc}$	٧	HD407L4019	
		SI	-0.3	_	$0.3~V_{\rm cc}$	٧	HD404019R, HD4074019	
			-0.3	_	$0.2~\mathrm{V_{cc}}$	٧	HD40L4019R	
			-0.3	_	$0.3~V_{\rm cc}$	٧	HD407L4019: $V_{CC}$ = 4.5 V to 5.5 V	
			-0.3	_	$0.1~V_{\rm cc}$	V	HD407L4019	
Input low voltage	$V_{\text{IL}}$	OSC <sub>1</sub>	-0.3	_	0.5	V	HD404019R, HD4074019, HD407L4019	
			-0.3	_	0.3	٧	HD40L4019R	
Output high voltage	V <sub>OH</sub>	SCK, SO	V <sub>cc</sub> -1.0	_	_	V	-I <sub>OH</sub> = 1.0 mA	
			V <sub>cc</sub> -0.5	_	_	V	$-I_{OH} = 0.5 \text{ mA}$	

Item	Symbol	Pin	Min	Тур	Max	Unit	Test Conditions	Notes
Output low voltage	V <sub>OL</sub>	SCK, SO	_	_	0.4	V	I <sub>OL</sub> = 1.6 mA	
Input/output leakage current	IIL	RESET, SCK, INT <sub>0</sub> , INT <sub>1</sub> , SI, SO, OSC <sub>1</sub>	_	_	1	μΑ	$V_{in} = 0 \text{ V to } V_{CC}$	1
Current dissipation in active mode	I <sub>cc</sub>	V <sub>cc</sub>	_	_	8.0	mA	HD404019R, HD4074019: $V_{CC} = 5 \text{ V}, f_{OSC} = 4 \text{ MHz}, \text{ divide by 4}$	2
			_	_	8.0	mA	HD40L4019R, HD407L4019: V <sub>CC</sub> = 5 V, f <sub>OSC</sub> = 4 MHz, divide by 4	2
			_	_	3.0	mA	HD40L4019R, HD407L4019: $V_{CC} = 3 V$ , $f_{OSC} = 3.58$ MHz, divide by 4	2
Current dissipation in standby mode	I <sub>SBY</sub>	V <sub>cc</sub>	_	_	2.0	mA	$V_{CC} = 5 \text{ V}, f_{OSC} = 4 \text{ MHz}, \text{ divide by 4}$	3
Current dissipation in stop mode	I <sub>STOP</sub>	V <sub>cc</sub>	)	_	10	μΑ	HD404019R, HD40L4019R: $V_{in}$ (TEST, R9 <sub>0</sub> ) = $V_{CC}$ – 0.3 V to $V_{CC}$ , $V_{in}$ (RESET) = 0 V to 0.3 V	4
			<		10	μΑ	HD4074019, HD407L4019: $V_{in}$ (TEST, R9 <sub>0</sub> ) = $V_{CC}$ – 0.3 V to $V_{CC}$ , $V_{in}$ (RESET) = 0 V to 0.3 V	
Stop mode retaining voltage	V <sub>STOP</sub>	V <sub>cc</sub>	2	_	7	V		

Notes: 1. Excluding pull-up MOS current and output buffer current (HD404019R, HD40L4019R) Excluding output buffer current (HD4074019, HD407L4019)

- 2. The MCU is in the reset state. Input/output current does not flow.
  - MCU in reset state, operation mode
  - ullet RESET,  $\overline{\text{TEST}}$ :  $V_{\text{cc}}$
  - $\bullet$  D<sub>0</sub> to D<sub>3</sub>, R3 to R9: V<sub>CC</sub>
  - $\bullet$  D<sub>4</sub> to D<sub>15</sub>, R0 to R2, RA<sub>0</sub>, RA<sub>1</sub>: V<sub>disp</sub>
- 3. The timer/counter operates with the fastest clock. Input/output current does not flow.
  - MCU in standby mode
  - Input/output in reset state
  - Serial interface: stop
  - RESET: GND
  - $\bullet$  TEST:  $V_{cc}$
  - $\bullet$  D<sub>0</sub> to D<sub>3</sub>, R3 to R9: V<sub>CC</sub>
  - $\bullet$  D $_{\!\scriptscriptstyle 4}$  to D $_{\!\scriptscriptstyle 15},$  R0 to R2, RA $_{\!\scriptscriptstyle 0},$  RA $_{\!\scriptscriptstyle 1};$  V $_{\!\scriptscriptstyle disp}$
- 4. Excluding pull-down MOS current.

#### Input/Output Characteristics for Standard Pins

 $\begin{array}{l} (HD404019R; \ V_{CC} = 3.5 \ V \ to \ 6 \ V, \ GND = 0 \ V, \ V_{disp} = V_{CC} - 40 \ V \ to \ V_{CC}, \ Ta = -20^{\circ}C \ to +75^{\circ}C \\ HD40L4019R; \ V_{CC} = 2.7 \ V \ to \ 6 \ V, \ GND = 0 \ V, \ V_{disp} = V_{CC} - 40 \ V \ to \ V_{CC}, \ Ta = -20^{\circ}C \ to +75^{\circ}C \\ HD4074019; \ V_{CC} = 4.5 \ V \ to \ 5.5 \ V, \ GND = 0 \ V, \ V_{disp} = V_{CC} - 40 \ V \ to \ V_{CC}, \ Ta = -20^{\circ}C \ to +75^{\circ}C \\ HD407L4019; \ V_{CC} = 3.0 \ V \ to \ 5.5 \ V, \ GND = 0 \ V, \ V_{disp} = V_{CC} - 40 \ V \ to \ V_{CC}, \ Ta = -20^{\circ}C \ to +75^{\circ}C \\ unless otherwise specified) \end{array}$ 

Item	Symbol	Pin	Min	Тур	Max	Unit	Test Conditions	Note
Input high voltage	V <sub>IH</sub>	D <sub>o</sub> to D <sub>3</sub> , R3 to R9	0.7 V <sub>cc</sub>	_	V <sub>cc</sub> + 0.3	V	HD404019R, HD4074019	
			0.8 V <sub>CC</sub>	_	V <sub>CC</sub> + 0.3	V	HD40L4019R	
			0.7 V <sub>CC</sub>	_	V <sub>CC</sub> + 0.3	V	HD407L4019:	
							$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$	
			$0.8~\mathrm{V}_{\mathrm{cc}}$	_	$V_{cc}$ + 0.3	V	HD407L4019	
Input low voltage	$V_{IL}$	$D_0$ to $D_3$ , R3 to R9	-0.3	_	0.3 V <sub>cc</sub>	V	HD404019R, HD4074019	
			-0.3	_	$0.2~\mathrm{V}_\mathrm{cc}$	V	HD40L4019R	
			-0.3	_	$0.3~\mathrm{V}_\mathrm{cc}$	V	HD407L4019:	
							$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$	
			-0.3	<b></b>	0.2 V <sub>cc</sub>	V	HD407L4019	
Output high	$V_{OH}$	$D_0$ to $D_3$ ,	$V_{\rm CC}-1.0$		<del>-</del>	V	HD404019R, HD40L4019R:	1
voltage		R3 to R8			<u> </u>		$-I_{OH} = 1.0 \text{ mA}$	
			$V_{\text{CC}} - 0.5$	_	0	V	HD404019R, HD40L4019R:	1
							$-I_{OH} = 0.5 \text{ mA}$	
Output low voltage	V <sub>OL</sub>	$D_0$ to $D_3$ , R3 to R8	_	_	0.4	V	I <sub>OL</sub> = 1.6 mA	
Input/output	:   I <sub>IL</sub>	$D_0$ to $D_3$ ,	_	_	1	μ <mark>A</mark>	HD404019R, HD40L4019R:	2
leakage current		R3 to R9					$V_{in} = 0 \text{ V to } V_{CC}$	
		$D_0$ to $D_3$ ,	_	_	1	μΑ	HD4074019, HD407L4019:	3
		R3 to R8, R9 <sub>1</sub> to R9 <sub>3</sub>					$V_{in} = 0 \text{ V to } V_{CC}$	
		R9 <sub>0</sub>	_	_	20	μΑ		
Pull-up	$-I_{PU}$	$D_0$ to $D_3$ ,	30	_	150	μΑ	HD404019R, HD40L4019R:	4
MOS current		R3 to R9					$V_{CC} = 5 \text{ V}, V_{in} = 0 \text{ V}$	

Notes: 1. Applied to I/O pins selected as CMOS output by mask option.

- 2. Excluding pull-up MOS current and output buffer current.
- 3. Excluding output buffer current.
- 4. Applied to I/O pins selected as with pull-up MOS by mask option.

### **Input/Output Characteristics for High Voltage Pins**

 $\begin{array}{l} \text{(HD404019R: $V_{CC}=3.5$ V to 6 V, GND=0$ V, $V_{disp}=V_{CC}-40$ V to $V_{CC}$, $Ta=-20^{\circ}C$ to $+75^{\circ}C$ \\ \text{HD40L4019R: $V_{CC}=2.7$ V to 6 V, GND=0$ V, $V_{disp}=V_{CC}-40$ V to $V_{CC}$, $Ta=-20^{\circ}C$ to $+75^{\circ}C$ \\ \text{HD4074019: $V_{CC}=4.5$ V to 5.5$ V, GND=0$ V, $V_{disp}=V_{CC}-40$ V to $V_{CC}$, $Ta=-20^{\circ}C$ to $+75^{\circ}C$ \\ \text{HD407L4019: $V_{CC}=3.0$ V to 5.5$ V, GND=0$ V, $V_{disp}=V_{CC}-40$ V to $V_{CC}$, $Ta=-20^{\circ}C$ to $+75^{\circ}C$ \\ \text{unless otherwise specified)} \end{array}$ 

Item	Symbol	Pin	Min	Тур	Max	Unit	Test Conditions	Note
Input high voltage	$V_{IH}$	$D_4$ to $D_{15}$ , R0 to R2, RA <sub>0</sub> , RA <sub>1</sub>	0.7 V <sub>cc</sub>	_	V <sub>cc</sub> + 0.3	V	HD404019R, HD4074019	
			0.8 V <sub>cc</sub>	_	V <sub>cc</sub> + 0.3	V	HD40L4019R:	
							$V_{CC} = 3.5 \text{ V to } 6.0 \text{ V}$	
			0.7 V <sub>CC</sub>	_	V <sub>cc</sub> + 0.3	V	HD407L4019:	
							$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$	
			0.8 V <sub>cc</sub>	_	V <sub>cc</sub> + 0.3	V	HD407L4019	
Input low voltage	V <sub>IL</sub>	D <sub>4</sub> to D <sub>15</sub> , R0 to R2, RA <sub>0</sub> , RA <sub>1</sub>	V <sub>cc</sub> – 40	_	0.3 V <sub>cc</sub>	V	HD404019R, HD4074019	
			V <sub>cc</sub> - 40	_	0.2 V <sub>cc</sub>	V	HD40L4019R:	
							$V_{CC} = 3.5 \text{ V to } 6.0 \text{ V}$	
			V <sub>cc</sub> - 40		0.3 V <sub>cc</sub>	V	HD407L4019:	
							$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$	
			V <sub>cc</sub> - 40	_	0.2 V <sub>cc</sub>	V	HD407L4019	
Output high	V <sub>OH</sub>	D4 to D15	V <sub>cc</sub> - 3.0	_		٧	HD404019R, HD40L4019R:	
voltage					4		$-I_{OH} = 15 \text{ mA},$	
							$V_{cc} = 5 \text{ V} \pm 20\%$	
			$V_{\rm CC}-2.0$	_	_	V	HD404019R, HD40L4019R:	
							$-I_{OH} = 10 \text{ mA},$	
							$V_{cc} = 5 \text{ V} \pm 20\%$	
			$V_{\rm CC}-1.0$	_	_	V	HD404019R, HD40L4019R:	
							$-I_{OH} = 4 \text{ mA}$	
			$V_{\rm CC} - 3.0$	_	_	V	HD4074019: $-I_{OH} = 15 \text{ mA}$	
			V <sub>CC</sub> - 2.0	_	_	V	HD4074019: $-I_{OH} = 10 \text{ mA}$	
			V <sub>CC</sub> - 1.0	_	_	V	HD4074019: $-I_{OH} = 4 \text{ mA}$	
			$V_{\text{CC}} - 3.0$	_	_	V	HD407L4019: $-I_{OH} = 15 \text{ mA},$	
							$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$	
			$V_{\rm CC}-2.0$	_	_	V	HD407L4019: $-I_{OH} = 10 \text{ mA}$	
			V <sub>cc</sub> - 1.0	_	_	V	HD407L4019: $-I_{OH} = 4 \text{ mA}$	

Item	Symbol	Pin	Min	Тур	Max	Unit	Test Conditions	Note
Output high	V <sub>OH</sub>	R0 to R2	V <sub>CC</sub> - 3.0	_	_	V	HD404019R, HD40L4019R:	
voltage							$-I_{OH}$ = 3 mA, $V_{CC}$ = 5 V $\pm$ 20%	
			V <sub>CC</sub> - 2.0	_	_	V	HD404019R, HD40L4019R:	
							$-I_{OH}$ = 2 mA, $V_{CC}$ = 5 V $\pm$ 20%	
			V <sub>CC</sub> - 1.0	_	_	V	HD404019R, HD40L4019R:	
							$-I_{OH} = 0.8 \text{ mA}$	
			V <sub>CC</sub> - 3.0	_	_	V	$HD4074019: -I_{OH} = 3 \text{ mA}$	
			V <sub>CC</sub> - 2.0	_	_	V	HD4074019: $-I_{OH} = 2 \text{ mA}$	
			V <sub>CC</sub> - 1.0	_	_	V	HD4074019: -I <sub>OH</sub> = 0.8 mA	
			V <sub>cc</sub> - 3.0	_	_	V	$HD407L4019: -I_{OH} = 3 \text{ mA},$	
							$V_{CC}$ = 4.5 V to 5.5 V	
			V <sub>CC</sub> - 2.0	_	_	V	HD407L4019: -I <sub>OH</sub> = 2 mA	
			V <sub>CC</sub> - 1.0	_	_	V	HD407L4019: -I <sub>OH</sub> = 0.8 mA	
Output low	V <sub>OL</sub>	D <sub>4</sub> to D <sub>15</sub> ,	_	_	V <sub>cc</sub> - 37	V	HD404019R, HD40L4019R: 1	1
voltage		R0 to R2					$V_{disp} = V_{CC} - 40 \text{ V}$	
			3	_	V <sub>cc</sub> – 37	V	HD404019R, HD40L4019R: 2	2
							150 k $\Omega$ at V $_{\text{cc}}$ – 40 V	
			_	$\rightarrow$	$V_{cc} - 37$	V	HD4074019, HD407L4019:	
			4				150 k $\Omega$ at V $_{\text{cc}}$ – 40 V	
Input/output	:   I <sub>IL</sub>	$D_4$ to $D_{15}$ ,	_	-	20	μΑ	HD404019R, HD40L4019R: 3	3
leakage current		R0 to R2,		•			$V_{in} = V_{CC} - 40 \text{ V to } V_{CC}$	
odiront		RA <sub>0</sub> , RA <sub>1</sub>						
			_	_	20	μΑ	HD4074019, HD407L4019: 4	4
							$V_{in} = V_{CC} - 40 \text{ V to } V_{CC}$	
Pull-down	$I_{PD}$	$D_4$ to $D_{15}$ ,	125	_	900	μΑ	HD404019R, HD40L4019R: 1	1
MOS current		R0 to R2,					$V_{\text{disp}} = V_{\text{CC}} - 35 \text{ V}, V_{\text{in}} = V_{\text{CC}}$	
Janon		RA <sub>0</sub> , RA <sub>1</sub>					•	

Notes: 1. Applied to I/O pins selected as with pull-up MOS by mask option.

- 2. Applied to I/O pins selected as with pull-up MOS (PMOS open drain) by mask option.
- 3. Excluding pull-down MOS current and output buffer current.
- 4. Excluding output buffer current.

#### **AC Characteristics**

 $\begin{array}{l} (HD404019R;\ V_{CC}=3.5\ V\ to\ 6\ V,\ GND=0\ V,\ V_{disp}=V_{CC}-40\ V\ to\ V_{CC},\ Ta=-20^{\circ}C\ to\ +75^{\circ}C \\ HD40L4019R;\ V_{CC}=2.7\ V\ to\ 6\ V,\ GND=0\ V,\ V_{disp}=V_{CC}-40\ V\ to\ V_{CC},\ Ta=-20^{\circ}C\ to\ +75^{\circ}C \\ HD4074019;\ V_{CC}=4.5\ V\ to\ 5.5\ V,\ GND=0\ V,\ V_{disp}=V_{CC}-40\ V\ to\ V_{CC},\ Ta=-20^{\circ}C\ to\ +75^{\circ}C \\ HD407L4019;\ V_{CC}=3.0\ V\ to\ 5.5\ V,\ GND=0\ V,\ V_{disp}=V_{CC}-40\ V\ to\ V_{CC},\ Ta=-20^{\circ}C\ to\ +75^{\circ}C \\ unless otherwise\ specified) \end{array}$ 

Item	Symbol	Pin	Min	Тур	Max	Unit	Test Conditions	Note
Oscillation frequency	f <sub>osc</sub>	OSC <sub>1</sub> , OSC <sub>2</sub>	0.4	4	4.5	MHz	HD404019R: divide by 4	
			0.4	4	4.5	MHz	HD40L4019R:	
							$V_{CC}$ = 3.5 V to 6.0 V, divide by 4	
			0.4	_	3.58	MHz	HD40L4019R: divide by 4	
			0.2	4	4.5	MHz	HD4074019: divide by 4	
			0.2	4	4.5	MHz	HD407L4019:	
							$V_{CC}$ = 4.5 V to 5.5 V, divide by 4	
			0.2	_	3.58	MHz	HD407L4019	
Instruction cycle time	t <sub>cyc</sub>		0.89	1	20	μs	HD404019R	
			0.89	1	10	μs	HD40L4019R:	
				$\wedge$			$V_{cc}$ = 3.5 V to 6.0 V	
			1.12	_	10	μs	HD40L4019R	
			0.89	1	20	μs	HD4074019: divide by 4	
			0.89	1	20	μs	HD407L4019:	
							$V_{cc}$ = 4.5 V to 5.5 V, divide by 4	
			1.12	_	20	μs	HD407L4019	
Oscillation stabilization time	t <sub>RC</sub>	OSC <sub>1</sub> , OSC <sub>2</sub>		_	20	ms	HD404019R, HD4074019	1
			_		20	ms	HD40L4019R:	1
							$V_{cc} = 3.5 \text{ V to } 6.0 \text{ V}$	
			_	_	40	ms	HD40L4019R	1
			_	_	20	ms	HD407L4019:	1
							$V_{cc} = 4.5 \text{ V to } 5.5 \text{ V}$	
			_	_	40	ms	HD407L4019	1

Notes: 1. The oscillator stabilization time is the period from when  $V_{\rm CC}$  reaches its minimum allowable voltage (HD404019R/HD40L4019R: 3.5 V, HD4074019: 4.5 V, HD407L4019: 3.0 V (3.5 V when  $V_{\rm CC}$  = 3.5 V to 6.0 V)) at power-on until when the oscillator stabilizes, or after RESET goes high by MCU reset to quit stop mode. At power-on or when recovering from stop mode, apply the RESET input for more than  $t_{\rm RC}$  to meet the necessary time for oscillator stabilization. When using a crystal or ceramic oscillator, consult with the crystal oscillator manufacturer since the oscillator stabilization time depends on the circuit constants and stray capacitance. (See figure 26.)

Item	Symbol	Pin	Min	Тур	Max	Unit	Test Conditions	Note
External clock high width	t <sub>CPH</sub>	OSC <sub>1</sub>	92	_	_	ns	HD404019R, HD4074019: divide by 4	1
			92	_	_	ns	HD40L4019R:	1
							$V_{CC}$ = 3.5 V to 6.0 V, divide by 4	
			120	_	_	ns	HD40L4019R: divide by 4	1
			92	_	_	ns	HD407L4019:	1
							$V_{CC}$ = 4.5 V to 5.5 V, divide by 4	
			115	_	_	ns	HD407L4019	1
External clock low width	t <sub>CPL</sub>	OSC <sub>1</sub>	92	_	_	ns	HD404019R, HD4074019: divide by 4	1
			92	_	_	ns	HD40L4019R:	1
							$V_{CC}$ = 3.5 V to 6.0 V, divide by 4	
			120	_	_	ns	HD40L4019R: divide by 4	1
			92	_	_	ns	HD407L4019:	1
			J				$V_{CC}$ = 4.5 V to 5.5 V, divide by 4	
			115	_	_	ns	HD407L4019	1
External clock rise time	t <sub>CPr</sub>	OSC <sub>1</sub>			20	ns		1
External clock fall time	t <sub>CPf</sub>	OSC <sub>1</sub>	_	_	20	ns		1
INT₀ high width	t <sub>IH</sub>	ĪNT <sub>0</sub>	2	_	+(	t <sub>cyc</sub>		2
INT <sub>0</sub> low width	t <sub>IL</sub>	ĪNT <sub>0</sub>	2	_	_	t <sub>cyc</sub>		2
INT₁ high width	t <sub>IH</sub>	ĪNT <sub>1</sub>	2	_	_	t <sub>cyc</sub>		2
ĪNT₁ low width	t <sub>IL</sub>	ĪNT <sub>1</sub>	2	_	_	t <sub>cyc</sub>	<b>9</b> 2	2
RESET high width	t <sub>RSTH</sub>	RESET	2	_	_	t <sub>cyc</sub>	Cx	3
Input	C <sub>in</sub>	All pins	_	_	30	pF	HD404019R, HD40L4019R:	
capacitance							$f = 1 MHz, V_{in} = 0 V$	
		All pins	_	_	30	pF	HD4074019, HD407L4019:	
		except R9 <sub>0</sub>					$f = 1 MHz, V_{in} = 0 V$	
		R9 <sub>0</sub>	_	_	180	pF		
RESET fall time	t <sub>RSTf</sub>		_	_	20	ms		3

Notes: 1. See figure 26.

2. See figure 27.

3. See figure 28.

#### **Serial Interface Timing Characteristics**

 $\begin{array}{l} (HD404019R:\,V_{CC}=3.5\;V\;to\;6\;V,\,GND=0\;V,\,V_{disp}=V_{CC}-40\;V\;to\;V_{CC},\,Ta=-20^{\circ}C\;to\;+75^{\circ}C\\ HD40L4019R:\,V_{CC}=2.7\;V\;to\;6\;V,\,GND=0\;V,\,V_{disp}=V_{CC}-40\;V\;to\;V_{CC},\,Ta=-20^{\circ}C\;to\;+75^{\circ}C\\ HD4074019:\,V_{CC}=4.5\;V\;to\;5.5\;V,\,GND=0\;V,\,V_{disp}=V_{CC}-40\;V\;to\;V_{CC},\,Ta=-20^{\circ}C\;to\;+75^{\circ}C\\ HD407L4019:\,V_{CC}=3.0\;V\;to\;5.5\;V,\,GND=0\;V,\,V_{disp}=V_{CC}-40\;V\;to\;V_{CC},\,Ta=-20^{\circ}C\;to\;+75^{\circ}C\\ HD407L4019:\,V_{CC}=3.0\;V\;to\;5.5\;V,\,GND=0\;V,\,V_{disp}=V_{CC}-40\;V\;to\;V_{CC},\,Ta=-20^{\circ}C\;to\;+75^{\circ}C\\ unless otherwise specified) \end{array}$ 

Item	Symbol	Pin	Min	Тур	Max	Unit	Test Conditions	Notes
Transmit clock cycle time	t <sub>Scyc</sub>	SCK output	1	_	_	t <sub>cyc</sub>	Load shown in figure 30	1, 2
Transmit clock high widths	t <sub>SCKH</sub>	SCK output	0.4	_	_	t <sub>cyc</sub>		1, 2
Transmit clock low widths	t <sub>SCKL</sub>	SCK output	0.4	_	_	t <sub>cyc</sub>		1, 2
Transmit clock rise time	t <sub>SCKr</sub>	SCK output	_	_	40	ns	HD404019R, HD4074019, HD407L4019	1, 2
			_	_	40	ns	HD40L4019R:	1, 2
							$V_{cc} = 3.5 \text{ V to } 6.0 \text{ V}$	
				_	200	ns	HD40L4019R	1, 2
Transmit clock fall time	t <sub>SCKf</sub>	SCK output			40	ns	HD404019R, HD4074019, HD407L4019	1, 2
			-	A	40	ns	HD40L4019R:	1, 2
					A		$V_{cc} = 3.5 \text{ V to } 6.0 \text{ V}$	
			_	_	200	ns	HD40L4019R	1, 2
Transmit clock cycle time	t <sub>Scyc</sub>	SCK input	1	_		t <sub>cyc</sub>		1
Transmit clock high width	t <sub>SCKH</sub>	SCK input	0.4	_	_	t <sub>cyc</sub>	<b>/</b> _	1
Transmit clock low width	t <sub>SCKL</sub>	SCK input	0.4	_	_	t <sub>cyc</sub>	CX	1
Transmit clock completion detect time	t <sub>SCKHD</sub>	SCK input	1	_	_	t <sub>cyc</sub>		3
Transmit clock rise time	t <sub>SCKr</sub>	SCK input	_	_	40	ns		1
Transmit clock fall time		SCK input	_	_	40	ns		1

Notes: 1. See figure 29.

<sup>2.</sup> See figure 30.

<sup>3.</sup> Transmit clock completion detect time is the high level period after 8 pulses of transmit clock are input. The serial interrupt request flag is not set when the next transmit clock is input before the transmit clock completion detect time has passed.

Item	Symbol	Pin		Min	Тур	Max	Unit	Test Conditions	Notes
Serial output data delay time	t <sub>DSO</sub>	so		_	_	300	ns	HD404019R	1, 2
				_	_	300	ns	HD40L4019R:	1, 2
								$V_{CC} = 3.5 \text{ V to } 6.0 \text{ V}$	
				_	_	500	ns	HD40L4019R	1, 2
				_	_	200	ns	HD4074019	1, 2
				_	_	200	ns	HD407L4019:	1, 2
								$V_{cc} = 4.5 \text{ V to } 5.5 \text{ V}$	
				_	_	400	ns	HD407L4019	1, 2
Serial input data setup time	t <sub>SSI</sub>	SI		100	_	_	ns	HD404019R	1
				100	_	_	ns	HD40L4019R:	1
								$V_{cc} = 3.5 \text{ V to } 6.0 \text{ V}$	
Serial input data setup time	t <sub>ssi</sub>	SI		300	_	_	ns	HD40L4019R	1
				200	_	_	ns	HD4074019, HD407L4019	1
Serial input data hold time	t <sub>HSI</sub>	SI	7	200	_	_	ns	HD404019R	1
				200		_	ns	HD40L4019R:	1
				•				$V_{cc} = 3.5 \text{ V to } 6.0 \text{ V}$	
				400	_	4	ns	HD40L4019R	1
				100	_		ns	HD4074019	1
				100	_	V	ns	HD407L4019:	1
								$V_{cc} = 4.5 \text{ V to } 5.5 \text{ V}$	
				200	_	_	ns	HD407L4019	1

Notes: 1. See figure 29. 2. See figure 30.

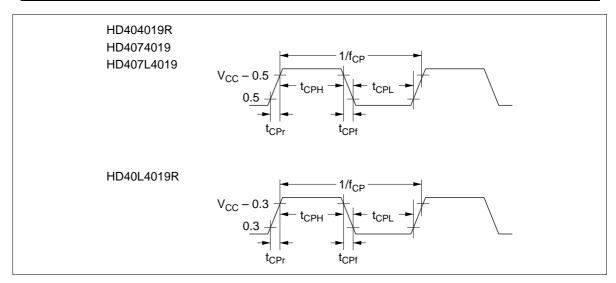


Figure 26 Oscillator Timing

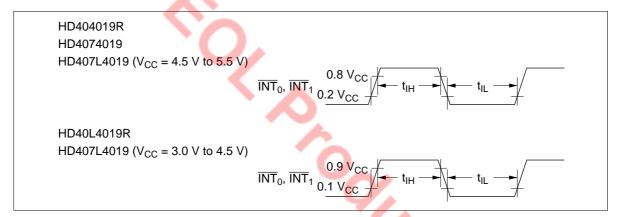


Figure 27 Interrupt Timing

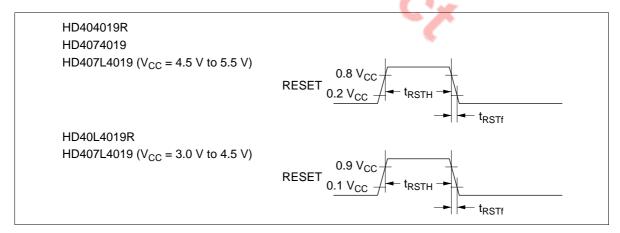


Figure 28 Reset Timing

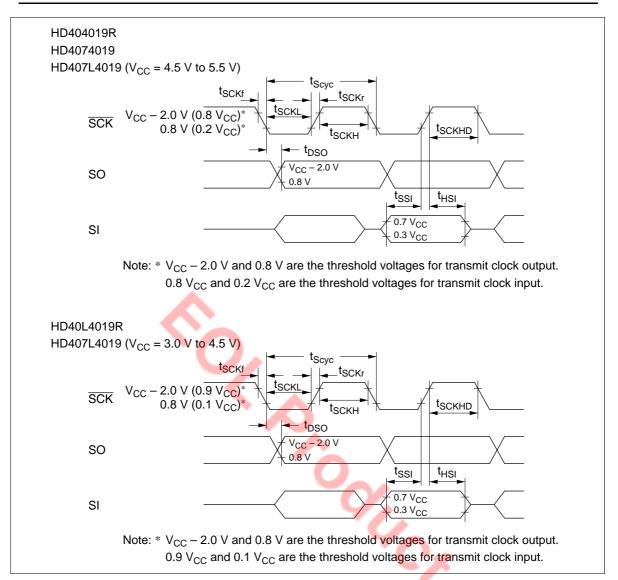


Figure 29 Timing of Serial Interface

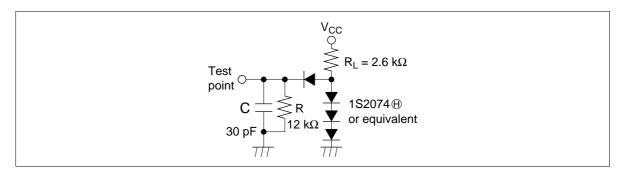


Figure 30 Timing Load Circuit

## **HD404019R Option List**

Please check off the appropriate applications and enter the necessary information.

☐ 5 V operation: HD404019R	
☐ Low-voltage operation: HD40L4019R	

Date of order	
Customer	
Dept.	
Name	
ROM code name	
LSI type number (Hitachi's entry)	

1. I/O option

Note: I/O options masked by	are not available.
-----------------------------	--------------------

	Pin	1/	0		I/O option Pin		Pin	1/	0		I/C	) opti	on				
		17	0	Α	В	С	D	Е			"	0	Α	В	O	D	Е
	00	σ	I/O							R30		I/O					
	)1	dar	I/O						R3	R31		I/O					
	)2	Standard	I/O						l K3	R32		I/O					
	)3	S	I/O							R33		I/O					
	)4		I/O							R40		I/O					
	)5		I/O						R4	R41		I/O					
	06		I/O						11.4	R42		I/O					
	)7	ည	I/O			1/				R43		I/O					
	08	High voltage pins	I/O							R50		I/O					
	9	age	I/O						R5	R51		I/O					
	010	volt	I/O						K3	R52		I/O					
	)11	ф	I/O					)		R53		I/O					
	)12	王	I/O				•		<u></u>	R60	Standard pins	I/O					
	)13		I/O						R6	R61	lrd	I/O					
	D14		I/O							R62	pu	I/O					
	)15		I/O							R63	Sta	I/O					
										R70		I/O					
									R7	R71		I/O					
	R00		I/O						137	R72		I/O					
R0	R01		I/O							R73		I/O					
INU	R02		I/O							R80		I/O	P				
	R03	Su	I/O						R8	R81		I/O					
	R10	High voltage pins	I/O						1.0	R82		1/0					
R1	R11	lage	I/O							R83		I/O					
IX1	R12	l lo	I/O						R9	R90		I					
	R13	gh	I/O							R91		I					
	R20	<del>I</del>	I/O						113	R92		I					
R2	R21		I/O							R93		I					
114	R22		I/O						RA	RA0	High voltage pins	I					
	R23		I/O						104	RA1	T M	ı	Plea	se ma	rk on	RA1/V	/disp

- A: Without pull-up MOS (NMOS open drain) B: With pull-up MOS

- C: CMOS (not be used as input)
  D: Without pull-down MOS (PMOS open drain)
  E: With pull-down MOS

# HD404019R Option List

2. RA1/Vdisp	3. Divider (DIV)	
☐ RA1: Without pull-down MOS (D)	■ Divide by 4	
☐ Vdisp		
Note: If even one high-voltage pin is selected with I/O option E, pin RA1/Vdisp must be selected to function as Vdisp.	ı	
4. ROM code media Please specify the first type below (the upper bits an EPROM on-package microcomputer type (including		her), when using the
☐ EPROM: The upper bits and lower bits are mixe programmed to the same EPROM in a		
☐ EPROM: The upper bits and lower bits are sepa programmed to different EPROMS.	arated. The upper five bits an	d lower five bits are
5. System oscillator (OSC1 and OSC2)  Ceramic oscillator Crystal oscillator External clock		
6. Stop mode	7. Package	T
Used	HD404019R	HD40L4019R
☐ Not used	☐ DP-64S ☐ FP-64A	☐ DP-64S ☐ FP-64A
	☐ FP-64B	☐ FF-04A
		K

#### **Cautions**

- 1. Hitachi neither warrants nor grants licenses of any rights of Hitachi's or any third party's patent, copyright, trademark, or other intellectual property rights for information contained in this document. Hitachi bears no responsibility for problems that may arise with third party's rights, including intellectual property rights, in connection with use of the information contained in this document.
- 2. Products and product specifications may be subject to change without notice. Confirm that you have received the latest product standards or specifications before final design, purchase or use.
- 3. Hitachi makes every attempt to ensure that its products are of high quality and reliability. However, contact Hitachi's sales office before using the product in an application that demands especially high quality and reliability or where its failure or malfunction may directly threaten human life or cause risk of bodily injury, such as aerospace, aeronautics, nuclear power, combustion control, transportation, traffic, safety equipment or medical equipment for life support.
- 4. Design your application so that the product is used within the ranges guaranteed by Hitachi particularly for maximum rating, operating supply voltage range, heat radiation characteristics, installation conditions and other characteristics. Hitachi bears no responsibility for failure or damage when used beyond the guaranteed ranges. Even within the guaranteed ranges, consider normally foreseeable failure rates or failure modes in semiconductor devices and employ systemic measures such as fail-safes, so that the equipment incorporating Hitachi product does not cause bodily injury, fire or other consequential damage due to operation of the Hitachi product.
- 5. This product is not designed to be radiation resistant.
- 6. No one is permitted to reproduce or duplicate, in any form, the whole or part of this document without written approval from Hitachi.
- 7. Contact Hitachi's sales office for any questions regarding this document or Hitachi semiconductor products.

SCX.